

μPD75316 Family (μPD75304/306/308/312/316/P308/P316A) 4-Bit, Single-Chip Microcontrollers With LCD Controller/Driver

June 1994

Description

The µPD75316 family of high-performance 4-bit single chip CMOS microcontrollers includes the following devices:

μPD75304 μPD75312 μPD75306 μPD75316 μ PD75308

μPD75P316A

μPD75P308

The 75316 family features an on-chip LCD controller and driver with up to 16K bytes of ROM and 1024 nibbles of RAM. The instruction set operates on 1-, 4-, and 8-bit data.

Timing is generated by two oscillators. The main oscillator normally drives the CPU and most peripherals. The 32.768-kHz subsystem oscillator provides time keeping when the main oscillator is turned off. Since CMOS power dissipation is proportional to clock rate, the 75316 family provides a software selectable instruction cycle time from 0.95 μ sec to 122 μ sec. The STOP and HALT modes turn off parts of the microcontroller for additional power savings. The data retention mode retains RAM contents down to 2.0 V.

Features

- LCD controller/driver for up to 128 segments
 - 32 segment lines
 - Four common lines
 - Static, 1/2 or 1/3 bias
 - LCD resistor ladder available on ROM versions
- Subsystem oscillator allows watch timer and LCD to operate in power-down modes
- 8-bit synchronized serial interface
 - Full-duplex, three-wire mode
 - Half-duplex, two-wire mode
 - NEC serial bus interface (SBI) mode

- □ Timers: three channels
 - 8-bit timer/event counter
 - 8-bit interval timer
 - Watch (clock) timer: 0.5-sec interrupt request
- □ 32 I/O lines
 - Eight input-only lines
 - 16 bidirectional I/O lines
 - Eight 10-volt n-channel, open-drain I/O lines
 - Direct LED drive from 12 lines
 - 31 software selectable pullup resistors
 - Eight mask selectable resistors (ROM versions only)
- □ Bit sequential buffer
 - 16-bit, bit addressable memory
- Standard 75X instruction set
 - 4-bit arithmetic and logic
 - 4- and 8-bit transfer instructions
- Minimum instruction execution times
 - 0.95, 1.91, and 15.3 μ s using 4.19-MHz main system clock
 - 122 µs selectable using 32.768-kHz subsystem clock
- Eight 4-bit registers
 - Usable as four 8-bit registers
- Memory-mapped on-chip peripherals
- Vectored interrupt controller
 - 12 edge detect inputs
 - Five vectored interrupts
- CMOS power saving and battery operation
 - Normal operating mode; 2.5 mA typical at 5 V
 - HALT mode; 0.5 mA typical
 - STOP mode; 0.1 μA typical
 - Data retention down to 2 volts
- Operating voltage ranges
 - ROM and 75P316A OTP/EPROM version; V_{DD} from 2.7 to 6.0 V
 - 75P308 (standard OTP/EPROM); $V_{DD} = 5 \text{ V} \pm 5\%$

Internal High-Capacity ROM and RAM

	75304	75306	75308	75312	75316	75P308	75P316A
ROM	4K bytes	6K bytes	8K bytes	12K bytes	16K bytes	_	
PROM	_	_	_			8K bytes	16K bytes
RAM	512 nibbles	1024 nibbles					

µPD75316 Family



Ordering Information

Part Number Quality Grade		ROM	Package Type	Package Drawing	
μPD75304GF-xxx-3B9	Standard	Mask	80-pin plastic QFP	P80GF-80-3B9-1	
μPD75304GF(A)-xxx-3B9	Special	-			
μPD75306GF-xxx-3B9	Standard	-			
μPD75306GF(A)-xxx-3B9	Special	_			
μPD75308GF-xxx-3B9	Standard	-			
μPD75308GF(A)-xxx-3B9	Special	-			
μPD75312GF-xxx-3B9	Standard	-			
μPD75312GF(A)-xxx-3B9	Special	-			
μPD75316GF-xxx-3B9	Standard	-			
μPD75316GF(A)-xxx-3B9	Special	-			
μPD75P308GF	Standard	ФТР	80-pin plastic QFP	P80GF-80-3B9-1	
μPD75P308K	Standard	EPROM	80-pin ceramic LCC with window	X80KW-80A	
μPD75P316GF (Note 3)	Standard	OTP	80-pin plastic QFP	P80GF-80-3B9-1	
μPD75P316AGF	Standard	Low- voitage OTP	80-pin plastic QFP QFP	P80GF-80-3B9-1	
μPD75P316AK	Standard	Low- voltage EPROM	80-pin ceramic LCC with window	X80KW-80A	

Notes:

- (1) Engineering samples are supplied in an 80-pin ceramic QFP.
- (2) xxx indicates ROM code.
- (3) This part has been superseded by the μ PD75P316AGF

Device Grades

The devices in the μ PD75316 family are available in standard or special quality grades. Special grade devices have the symbol (A) embedded in the part number; a μ PD75308GF is a standard grade device and a μ PD75308GF(A) is a special grade device. The selection of the correct grade depends upon the application.

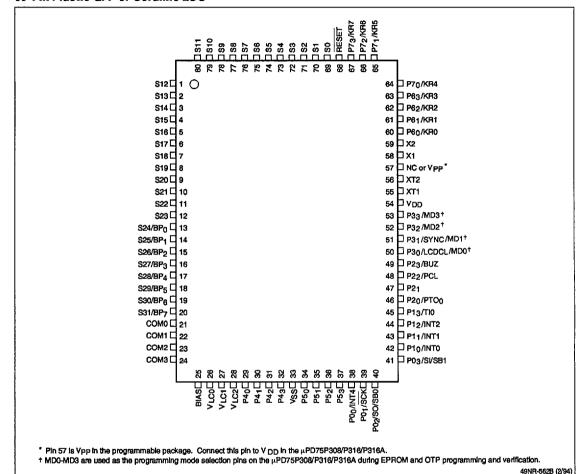
Differences Between Special and Standard Quality Grades

	Special	Standard	
Applications	Automotive and transportation equipment, traffic control systems, anti-disaster systems, anti-crime systems	Computers, office equipment, communications, test and measurement, machine tools, industrial robots, audio and visual equipment, other consumer products.	
LED direct drive	No	Yes	
Absolute maximum ratings	Differences in low-level a current; refer to Electrica	•	
DC characteristics	Differences in low-voltage outputs; refer to Electrical Specifications.		



Pin Configurations

80-Pin Plastic QFP or Ceramic LCC



µPD75316 Family



Pin Identification

Symbol	Function
BIAS	LCD power bias output
BP ₀ /S24 BP ₁ /S25 BP ₂ /S26 BP ₃ /S27 BP ₄ /S28 BP ₅ /S29 BP ₆ /S30 BP ₇ /S31	1-bit output ports BP ₀ - BP ₇ ; LCD segments S24-S31
сомо-сомз	LCD common output 0-3
NC/V _{PP}	No connection (programming pin for μPD75P308A)
P0 ₀ /INT4	Port 0 input; interrupt 4
P0 ₁ /SCK	Port 0 input; serial clock
P0 ₂ /SO/SB0	Port 0 input; serial out; serial bus interface 0
P0 ₃ /SI/SB1	Port 0 input; serial in; serial bus interface 1
P1 ₀ /INT0	Port 1 input; interrupt 0
P1 ₁ /INT1	Port 1 input; interrupt 1
P1 ₂ /INT2	Port 1 input; interrupt 2
P1 ₃ /T10	Port 1 input; timer 0 input
P2 ₀ /PTO ₀	Port 2 I/O; timer/event counter output
P2 ₁	Port 2 I/O
P2 ₂ /PCL	Port 2 I/O; programmable clock output
P2 ₃ /BUZ	Port 2 I/O; buzzer output
P3 ₀ /LCDCL/MD0	Port 3 I/O; LCD clock output; programming mode select 0 (µPD75P308A)
P3 ₁ /SYNC/MD1	Port 3 I/O; LCD SYNC output; programming mode select 1 (µPD75P308A)
P3 ₂ /MD2	Port 3 I/O; programming mode select 2 (µPD75P308A)
P3 ₃ /MD3	Port 3 I/O; programming mode select 3 (µPD75P308A)
P4 ₀ - P4 ₃	Port 4 I/O
P5 ₀ - P5 ₃	Port 5 I/O
P6 ₀ /KR0	Port 6 I/O; key scan input 0
P6 ₁ /KR1	Port 6 I/O; key scan input 1
P6 ₂ /KR2	Port 6 I/O; key scan input 2
P6 ₃ /KR3	Port 6 I/O; key scan input 3
P7 ₀ /KR4	Port 7 I/O; key scan input 4
P7 ₁ /KR5	Port 7 I/O; key scan input 5
P7 ₂ /KR6	Port 7 I/O; key scan input 6
P7 ₃ /KR7	Port 7 I/O; key scan input 7
RESET	Reset input
S0 - S23	LCD segment output
V _{LC0}	LCD drive level 0

Symbol	Function				
V _{LC1}	LCD drive level 1				
V _{LC2}	LCD drive level 2				
X1, X2	Main clock inputs				
XT1, XT2	Subsystem clock inputs				
V _{DD}	Positive power supply				
V _{SS}	Ground				

PIN FUNCTIONS

P0₀/INT4, P0₁/SCK, P0₂/SO/SB0, P0₃/SI/SB1. These pins can be used as 4-bit input port 0. P0₀ can also be used for vectored interrupt 4, which interrupts on either the leading edge or the trailing edge of the signal. P0₁ - P0₃ may also be used for the serial interface in the SBI or the 2- or 3-wire modes.

SI is the serial input, SO is the serial output, and SCK is the serial clock. SB0 and SB1 are the NEC serial bus interface pins 0 and 1. Reset causes these pins to default to the port 0 input mode.

 $P1_0/INT0$, $P1_1/INT1$, $P1_2/INT2$, $P1_3/T10$. These pins can be used as 4-bit input port 1. $P1_0$ and $P1_1$ can also be used for edge-triggered interrupts INT0 and INT1. $P1_2$ can be used for INT2, which is also an edge-triggered input, but one that generates an Interrupt request but does not cause a vectored interrupt.

P1₃ can be used as an input clock to the timer/event counter to count external events. Reset causes all Pl pins to default to the port 1 input mode.

P2₀/PTO₀, P2₁, P2₂/PCL, P2₃/BUZ. These pins can be used as 4-bit I/O port 2. When used as an output, the data is latched. When used as an input port, the port outputs are three-state. P2₀ can also be used as PTO₀, the output of the timer/event counter flip-flop (TOUT); P2₂ can be used as the output (PCL) for the clock generator; and P2₃ can be used to output square waves for a buzzer. Reset causes these pins to default to the port 2 input mode.



P3₀/LCDCL/MD0, P3₁/SYNC/MD1, P3₂/MD2,

P3₃/MD3. These pins are used for I/O port 3. Each bit in this port can be independently programmed to be either an input or an output. This port has latched outputs, and can directly drive LEDs. P3₀ and P3₁ can also be used respectively as LCD clock and LCD sync outputs.

 $P3_0$ - $P3_3$ are used as the programming mode select pins for the μ PD75P308/P316A during EPROM/OTP programming and verification. A reset signal causes this port to default to the input mode.

P40 - P43, P50 - P53. Port 4 and Port 5 are identical 4-bit I/O ports, which can be combined to function as a single 8-bit port. Latched outputs will directly drive LEDs. Outputs are n-channel open drain, and can withstand up to 10 volts; pullup resistor mask options are available for these ports. A reset signal causes these ports to default to the input mode at a high impedance or to a high level if a pullup resistor is present.

P6₀/KR0, P6₁/KR1, P6₂/KR2, P6₃/KR3 P7₀/KR4, P7₁/KR5, P7₂/KR6, P7₃/KR7. Ports 6 and 7 are 4-bit I/O ports, which can be combined to function as a single 8-bit port. Outputs are latched. Each pin of port 6 can be independently programmed to be either an input or an output; port 7 can be programmed to be either all inputs or all outputs. Alternately, these pins may be used to detect the falling edge of inputs KR0 - KR3 (port 6) and KR4 - KR7 (port 7). A reset signal causes these ports to default to the input mode.

S0 - S23. These are the LCD segment drivers.

COM0 - COM3. These are the LCD common input drivers.

BP₀/S24 - BP₇/S31. These can be used either as eight 1-bit ports or as additional LCD segment drivers. When used as segment outputs they are selectable in 4-bit increments.

 V_{LC0} - V_{LC2} - These pins are used to set the drive levels for the LCD. If the internal resistor ladder mask option is selected (on the $\mu PD7530x/31x$ only), these pins are outputs; if the internal resistor ladder is not selected, these pins are inputs to which an external resistor network must be connected.

BIAS. This output is used in conjunction with the V_{LC0} - V_{LC2} pins to set the LCD contrast level.

NC/V_{PP}. This pin may be left unconnected when using the μ PD7530x/31x. For the μ PD759308/P316A, the pin is used as the programming voltage input during the EPROM write/verify cycles. When the devices are not being programmed, this pin should be connected to V_{DD}. It must be connected to V_{DD} if the same circuit board is to be used for both programmable and non-programmable devices.

X1, X2. These pins are the main system clock inputs. The input can be from a ceramic resonator or a crystal; an external logic signal may also be used by applying it to X1 and its inverse to X2.

XT1, XT2. These pins are the subsystem clock inputs. The input can be from a ceramic resonator or a crystal; an external logic signal may also be used by applying it to XT1 with XT2 left open.

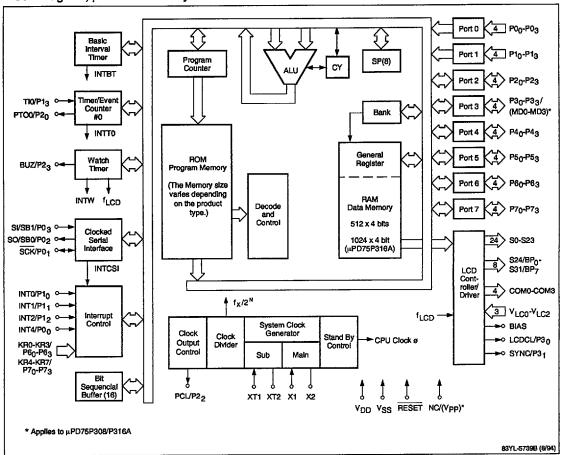
RESET. This is the reset input, and it is active low.

 V_{DD} . The system positive power supply pin.

Vss. System ground.



Block Diagram; µPD75316 Family





Product Comparison

Item	75304	75306	75308	75P308	75312	75316	75P316 (Note)	75P316A
Program memory			Mask ROM 0000H-1F7FH 8064 x 8 bits	OTP; EPROM 0000H-1F7FH 8064 x 8 bits	Mask ROM 0000H-2F7FH 12,160 x 8 bits	Mask ROM 0000H-3F7FH 16,256 x 8 bits	OTP 0000H-3F7FH 16,256 x 8 bits	OTP; EPROM 0000H-3F7FH 16,256 x 8 bits
Data memory	512 x 4 bits					1024 x 4 bits		
3-byte branch instructions	No	Yes	Yes	Yes	Yes	Yes	Yes	Yes
Other instruction set				Commo	n to the products			
Program counter	12-bit	13-bit	13-bit	13-bit	14-bit	14-bit	14-bit	14-bit
Ports 4 and 5 pullup resistor	Mask option	Mask option	Mask option	No	Mask option	Mask option	No	No
LCD resistor ladder	Mask option	Mask option	Mask option	No	Mask option	Mask option	No	No
V _{PP} , PROM program- ming pins	No	No	No	Yes	No	No	Yes	Yes
Operating voltage range	2.7 to 6.0 V	2.7 to 6.0 V	2.7 to 6.0 V	5 V ± 5%	2.7 to 6.0 V	2.7 to 6.0 V	5 V ± 5%	2.7 to 6.0 V
Package	80-pin plastic QFP			80-pin plastic QFP; 80-pin ceramic LCC with window		80-pin plastic QF	-p	80-pin plastic QFP; 80-pin ceramic LCC with window

0000H and

Note: The μ PD75P316 has been superseded by the μ PD75P316A.

CPU AND MEMORY ARCHITECTURE

The 75X architecture has two separate address spaces, one for program memory (ROM) and another for data memory (RAM).

Program Memory (ROM)

The ROM is addressed by the 12-, 13-, or 14-bit program counter. The size of the program counter and the amount of ROM present depend on which part is being used. The ROM contains program object code, interrupt vector table, a GETI instruction reference table, and table data. Table data can be obtained using table reference instruction MOVT.

Figure 1 is the program memory map for the 75316 family. It also shows the addressing range that can be made using a branch instruction or subroutine call instruction. In addition, the BR PCDE and BR PCXA instructions can be used for a branch where only the low 8 bits of the PC are changed.

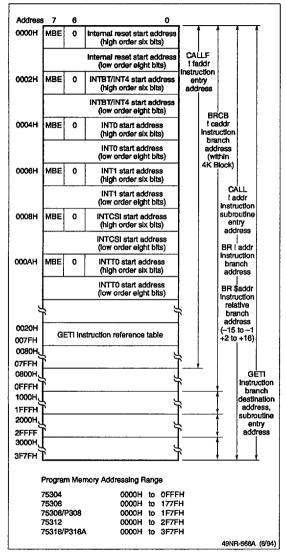
All locations in ROM except 0000H and 0001H can be used as program memory. However, if interrupts or GETI instructions are used, the locations corresponding to those functions cannot be used. Addresses are normally reserved as follows:

Vector address for RESET, and also

0001H	contains the MBE bit.					
0002H to 000BH	Interrupt vector addresses. Each vector address contains an MBE bit value. The interrupt service routines can start from any location except where noted above.					
0020H to 007FH	Table area for GETI instructions. The GETI instruction is used to access one 2-byte/3-byte or two 1-byte instructions using one byte of program memory. This is useful in compacting code.					







Program Counter (PC)

This is a 12/13/14-bit binary counter that contains the address of the current program memory location. The μ PD75304 contains a 12-bit PC; the 75306/308/P308 have a 13-bit PC; and the 75312/316/P316A have a 14-bit PC.

When an instruction is executed, the PC is automatically incremented by the number of bytes of the current instruction. When a branch instruction (BR, BRCB) is executed, the contents of the immediate data or register pair indicating the new address are loaded into some or all bits of the PC.

When a subroutine call instruction (CALL, CALLF) is executed or an interrupt is generated, the PC is incremented to point to the next instruction, and this information is saved on the stack. During an interrupt, the program status word (PSW) is also automatically saved on the stack. The address to be jumped to by the CALL or interrupt is then loaded into the PC.

When a return instruction (RET or RETS) is executed, the contents of the stack are restored to the PC. When a return instruction from interrupt (RETI) is executed, the PC and the PSW are restored.

Data Memory (RAM)

The data memory contains three memory banks (0, 1, and 15) in all devices except the μ PD75P316A, which contains five memory banks (0, 1, 2, 3, and 15). The RAM memory maps are shown in figures 2 and 3. The memory consists of general-purpose static RAM and peripheral control registers.

The memory banks are accessed using MBE (memory bank enable) and by programming the BS (bank select register). If MBE = 0, the lower 128 nibbles of memory bank 0 and the upper 128 nibbles of memory bank 15 are accessed. If MBE = 1, the upper four bits in the BS register will specify the memory bank. The values are 0H for memory bank 0, 1H for memory bank 1, 2H for memory bank 2, 3H for memory bank 3, and 0FH for memory bank 15.

Memory banks 0, 1, 2, and 3 each contain 256 nibbles. Although the memory is organized in nibbles, the 75X architecture allows the data to be manipulated in bytes, nibbles, and individual bits.

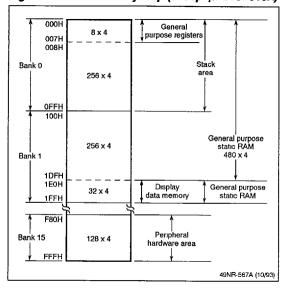
The data memory is used for storing processed data, general-purpose registers, and as a stack for subroutine or interrupt service. The last 32 nibbles of bank 1 are used to store the LCD display data. If this area is not completely used by the LCD, it may be used as general-purpose RAM. Because of its static nature, the RAM will



retain its data when CPU operation is stopped and the chip is in the standby mode, provided V_{DD} is at least 2 volts.

There are eight 4-bit, general-purpose registers in bank 0 starting at location 00H (see figure 4). These registers may also be used as four 8-bit registers. The on-chip peripheral control registers and ports reside in the upper 128 nibbles of bank 15. Bank 15 addresses not assigned to a register are not available as random memory except for the 16-bit sequential buffer. Also, the lower 128 nibbles of bank 15 do not contain RAM.

Figure 2. Data Memory Map (except "PD75P316A)



Addressing Modes

The µPD75316 family can address data memory and ports as individual bits, nibbles, or bytes. These addressing modes are as follows:

- 1-bit direct data memory
- 4-bit immediate
- 4-bit direct data memory
- 4-bit register indirect (@rpa)
- 8-bit immediate
- 8-bit direct data memory
- 8-bit register indirect (@HL)
- Bit manipulation
- Stack addressing

Table 1 shows the data memory addressing modes and table 2 shows the peripheral control register addressing. Figure 5 shows the data memory addressing modes for the μ PD75316 family.

Figure 3. μPD75P316A Data Memory Map

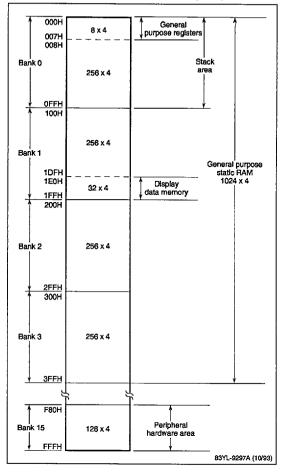




Figure 4. General-Purpose Register Configurations

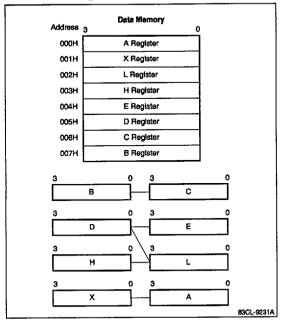


Table 1 Data Memory Addressing Modes

Addressing Mode	Format	How The Address is Formed		
1-bit direct addressing	mem.bit	If MBE = 0, the memory bank is bank 0 for addresses 00H-7FH and bank 15 for addresses 80H-FFH.		
		If MBE = 1, the memory bank is selected by the 4 bits of the MBS.		
		The bit to be manipulated is specified in mem.bit		
4-bit direct addressing	mem	If MBE = 0, the memory bank is bank 0 for addresses 00H-7FH, and bank 15 for addresses 80H-FFH.		
		If MBE = 1, the memory bank is selected by the 4 bits of the MBS.		
		The nibble to be manipulated is specified in mem.		
8-bit direct addressing	mem (must be an even address)	If MBE = 0, the memory bank is bank 0 for addresses 00H-7FH and bank for addresses 80H-FFH.		
		If MBE = 1, the memory bank is selected by the 4 bits of the MBS.		
		The byte to be manipulated is specified in mem.		
4-bit register indirect addressing	@HL	The memory bank is selected by MBE and the 4 bits of the MBS. The loca within the memory bank is contained in register HL.		
	@DE	The memory bank is always bank 0. The location within the memory bank is contained in register DE.		
	@DL	The memory bank is always bank 0. The location within the memory bank is contained in register DL		
8-bit register indirect addressing	@HL (must be an even address)	The memory bank is selected by MBE and the 4 bits of the MBS. The location within the memory bank is contained in register HL.		



Table 1. Data Memory Addressing Modes (cont)

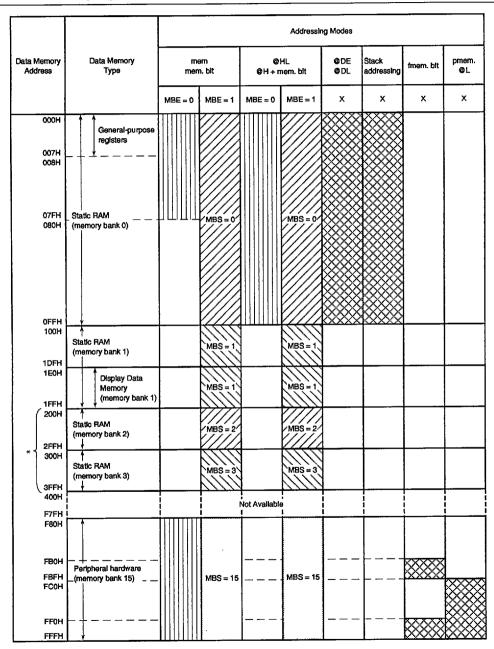
Addressing Mode	e Format	How The Address is Formed			
Bit manipulation addressing	fmem.bit	The memory bank is bank 15, and the location is fmem, where fmem = FB0H-FBFH for interrupts fmem = FF0H-FFFH I/O ports			
		The actual bit is specified in frem.bit			
	pmem.@L	The memory location is always FC0H to FFFH and is independent of MBE and MBS. The upper 10 address bits of the location are contained in the 10 high order bits of pmem and the 2 lower address bits are contained in the 2 upper bits of register L.			
		The bit to be manipulated is specified by the 2 lower bits of register L.			
	@H + mem.bit	The memory bank is selected by MBE and the 4 bits of the MBS, and the location within the memory bank is determined by the following: The 4 upper bits are the contents of register H The 4 lower bits are mem.			
		The actual bit is specified in mem.bit.			
Stack addressing		The memory bank is always bank 0. The location is indicated by the stack pointer (SP)			
MBE MBS mem mem.bit fmem and pmem	Memory bank enable bit Memory bank select register Location within a memory bank Bit at a specified memory location Specialized cases of mem				

Table 2. On-Chip Peripheral Addressing Modes

Manipulation	Addressing Mode	Applicable Hardware	
1-bit	With MBE = 0 (or MBE = 1 and MBS = 15), direct addressing with peripheral address specified in mem.bit	All hardware where bit manipulation can be performed	
	Direct addressing regardless of the setting of MBE and MBS with peripheral address specified in fmem.bit	ISTO, MBE IExxx, IRQxxx, PORTn.x	
	Indirect addressing regardless of the setting of MBE and MBS with peripheral address specified in pmem. @L	BSBn.x PORTn.x	
4-bit	With MBE = 0 (or MBE = 1 and MBS = 15), direct addressing with peripheral address specified in mem.bit	All hardware where 4-bit manipulation can be performed	
	With MBE = 1 and MBS = 15, register indirect addressing with peripheral address specified in HL	-	
8-bit	With MBE = 0 (or MBE = 1 and MBS = 15), direct addressing with peripheral address specified in mem; mem must be an even address	All hardware where 8-bit manipulation can be performed	
	With MBE = 1 and MBS = 15, register indirect addressing with peripheral address specified in HL; L register must contain an even number	-	



Figure 5. Data Memory Organization and Addressing Modes



X: MBE has no effect

MBE: Memory bank enable bit MBS: Memory bank select register

83YL-929BB (10/93)

^{*:} For µPD75P316A only



FUNCTIONAL DESCRIPTION

Input/Output Ports

The μ PD75316 family has eight 4-bit ports; six are input/output, two are input only. They also have eight 1-bit output ports. Figure 6 shows the structure of the ports and table 3 lists the features. Figure 6 also shows

the structure of inputs and outputs of the other pins.

Software selectable internal pullup resistors are available on ports 0, 1, 2, 3, 6, and 7. They are selectable in 4-bit units. Port 0, bit 0 does not have a pullup resistor. Mask option, bit-selectable internal pullup resistors are available for ports 4 and 5 of all mask ROM devices.

Table 3. Types and Features of Digital Ports

Port	Function	Operation and Features	Remarks	
Port 0	4-bit input	Can always be read or tested regardless of the	Pins also used for INT4, SCK, SO/SB0, SI/SB1.	
Port 1	_	operation mode.	Pins also used for INT0, INT1, INT2, TI0.	
Port 3 (Note 1)	4-bit input/output	Can be placed in input or output mode in 1-bit units.	Pins also used for LCDCL, SYNC, and MD0-MD3 (Note 2)	
Port 6			Pins also used for KR0 - KR3.	
Port 2	4-bit input/output	Can be placed in input or output mode in 4-bit	Port 2 pins are also used for PTO ₀ , PCL, BUZ.	
Port 7	-	units. Ports 6 and 7 can be paired for data input/output in 8-bit units.	Pins also used for KR4 - KR7.	
Ports 4, 5 (Note 1) 4-bit input/output (n-channel, open drain, 10 volts)		Can be placed in input or output mode in 4-bit units. Ports 4 and 5 can be paired for data input/output in 8-bit units.	Internal pullup resistor can be specified in 1-b units by mask option. (µPD7530x/31x only)	
Ports BP0-BP7	1-bit output	Data is output in 1-bit units. The BP0 - BP7 pins are also used as LCD segment pins S24 - S31. BP0 - BP7 and S24 - S31 can be changed by software.	The drive capacity is very small. Used for CMOS load drive.	

Notes:

- (1) These ports directly drive LEDs.
- (2) Port 3 lines are also used for MD0 MD3 in μPD75P308/P316A.



Figure 6. Input/Output Circuits (Sheet 1 of 2)

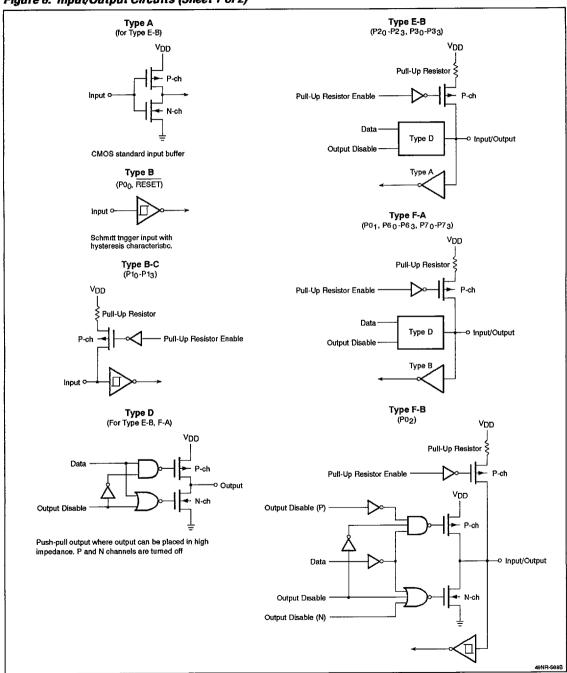
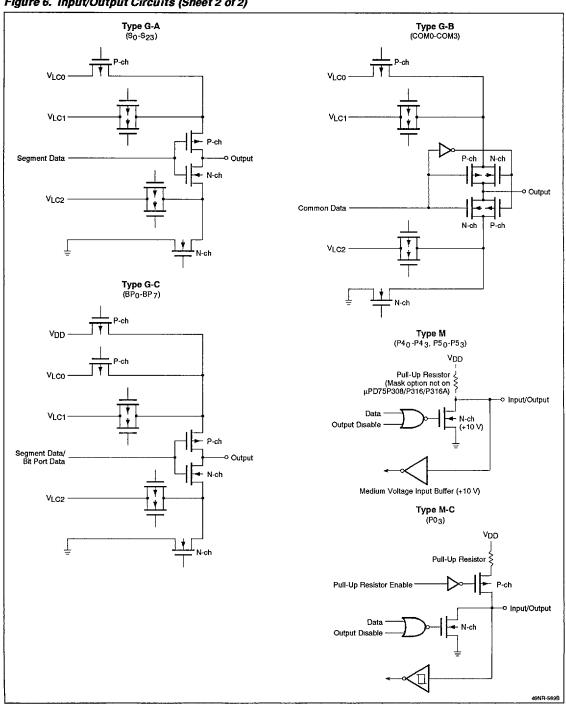




Figure 6. Input/Output Circuits (Sheet 2 of 2)





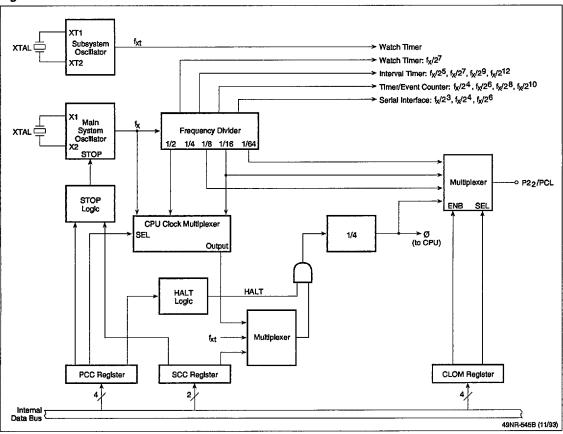
Clock Generator

The clock generator (figure 7) uses the crystal inputs X1 and X2 as a time base to provide clocks for the μ PD75316 family. The generator consists of an oscillator, frequency dividers, multiplexers, and three control registers (PCC, SCC, and CLOM). By programming PCC and CLOM, frequencies derived from the crystal are supplied to the CPU, interval timer, timer/event counter, watch timer, serial interface, and output pin PCL.

The PCC and SCC registers control the HALT and STOP logic and can also be used to set the CPU to operate at one of four speeds. The CLOM register controls the PCL output clock.

The clock generator also contains a subsystem clock consisting of an oscillator driven by an external crystal. It operates at 32-35 kHz and can be used as a clock source to the watch timer, LCD controller, and CPU.

Figure 7. Clock Generator

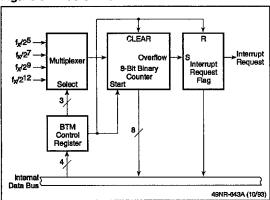




Basic Interval Timer

The basic interval timer (figure 8) provides continuous real-time interrupts. It consists of a multiplexer, 8-bit free-running counter, and 4-bit BTM control register. Each time the counter reaches FFH it causes an interrupt, overflows to 00H, and continues to count. The BTM register selects one of four clock inputs to the counter, clears the counter, and clears its interrupt request. The counter can generate 250-ms interrupts with a 4.19-MHz crystal; it also provides oscillator stabilization time when the chip leaves the STOP mode.

Figure 8. Basic Interval Timer

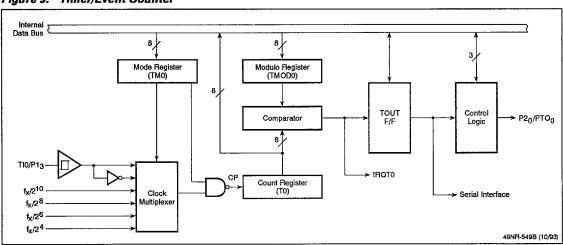


Timer/Event Counter (TM0)

The timer/event counter (figure 9) consists of an 8-bit modulo register, 8-bit comparator, 8-bit count register, clock multiplexer, mode control register TM0, and a TOUT flip-flop. Control logic allows the flip-flop signal PTO₀ to be output to port 2, bit 0.

An 8-bit value is loaded into the modulo register and a count register clock is selected by the clock multiplexer via control register TM0. The count register is incremented each time it receives a counter pulse (CP). When the value in the count register is equal to the count in the modulo register, the comparator generates a signal. This signal toggles the TOUT flip-flop and resets the count register to 00H. The count register will continue to count up unless stopped. Each time the comparator has a match, TOUT changes state and interrupt IRQT0 is generated. This signal can also be used as a clock for the serial interface.

Figure 9. Timer/Event Counter



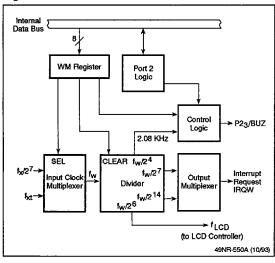


Watch Timer

The watch timer (figure 10) is normally the time source for keeping track of time of day. With a 4.19-MHz crystal, it will generate interrupt requests (not vectored interrupts) at 0.5-second or 3.91-ms intervals.

The watch timer consists of an input clock multiplexer, frequency divider, output multiplexer, control logic, and control register WM. When a subsystem clock is present, the timer can operate when the chip is in the STOP mode. It is also a clock source for the LCD controller and is capable of generating a 2-kHz buzzer output signal.

Figure 10. Watch Timer



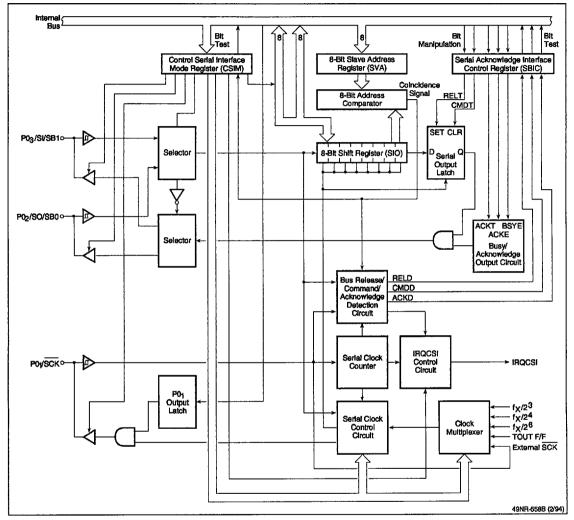
Serial Interface

The 8-bit serial interface (figure 11) allows the μ PD75316 family to communicate with other NEC or NEC-like serial interfaces. It consists of an 8-bit shift register (SIO), serial-out latch (SO), 8-bit address comparator, slave address register (SVA), control registers CSIM and SBIC, busy/acknowledge circuitry, bus release/detect circuitry, serial clock counter, clock multiplexer, and clock control circuitry. The three-wire interface consists of the serial data in (SI/SB1), serial data out (SO/SB0), and serial shift clock (SCK).

There are three modes of operation: 2-wire serial, 3-wire serial, and 2-wire SBI. The simplest modes are the 2/3-wire serial. In these modes, the 8-bit shift register is loaded with a byte of data and 8 clock pulses are generated. These pulses shift data out the SO line and data in from the SI line, thus, communicating in full duplex. Each time a byte of data is sent, a burst of eight clock pulses is generated and eight bits of data will be sent. Data may be sent either LSB or MSB first. The interface may also be set to receive data only; in this case SO is in the high-impedance state. One of four internal clocks or an external clock may be used to clock the data.



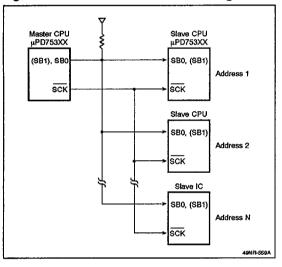
Figure 11. Serial Interface Block Diagram





The SBI mode uses a 2-wire interface (figure 12) with devices in a master/slave configuration. At any one time, there is a single master, with all other devices being slaves. The master can send addresses, commands, and data over the bus. The slaves are able to detect in hardware if their particular address has been sent, and can also detect whether a command or piece of data has been sent. There can be as many as 256 slave addresses, 256 commands, and 256 data types. All commands are user-defined, and it is possible to send commands that change slaves into masters; when this happens, the previous master becomes a slave. This type of work is done in firmware, and the bus can be as simple or complex as the user wishes.

Figure 12. SBI Mode Master/Slave Configuration



LCD Controller/Driver

The LCD controller/driver (figure 13) can be programmed to operate in any of four modes. It can operate in the static mode (drive 32 segments), the duplex mode (drive 64 segments), the triplex mode (drive 96 segments), or quadruplex mode (drive 128 segments). The duplex mode uses 1/2 bias, the triplex mode can use either 1/2 or 1/3 bias, and the quadruplex mode uses 1/3 bias.

The LCD controller automatically refreshes the LCD by taking data from the upper 32 nibbles of RAM in memory bank 1, and uses display data multiplexers, segment drivers S0-S31, and common drivers COM0-COM3 to drive the LCD. It is controlled by registers LCDM, LCDC, and PGMA. The LCD main controller clock (f_{LCD}) is provided by the watch timer. The LCD controller/driver can operate in the STOP mode as long as the watch timer is clocked by the subsystem clock.

Drive levels can be set internally by ordering the resistor ladder mask option on the μ PD7530x/31x mask ROM devices. Otherwise, external resistors can be connected to pins V_{LC0} - V_{LC2} and the BIAS pin. The BIAS pin can be used to control the contrast of the LCD.

Bit Sequential Buffer

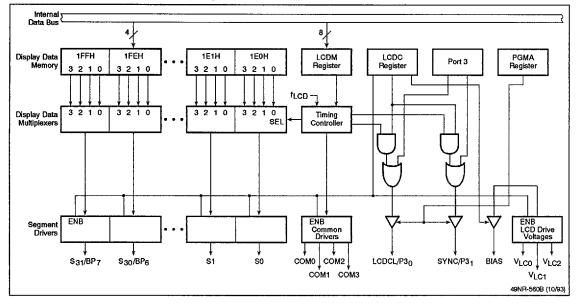
The 16-bit sequential buffer is the only general-purpose RAM in the upper half of data memory bank 15. All other locations in this bank either contain the on-chip peripheral control registers or are unused addresses.

The bit sequential buffer can be bit, nibble, or byte manipulated. Its bits are addressed by register L and they can be sequentially scanned by incrementing or decrementing L.

A typical application for this buffer might be to store data for the next serial output or to store data from a serial input. It could also be used to store data that is to be sent from a port.



Figure 13. LCD Controller Block Diagram





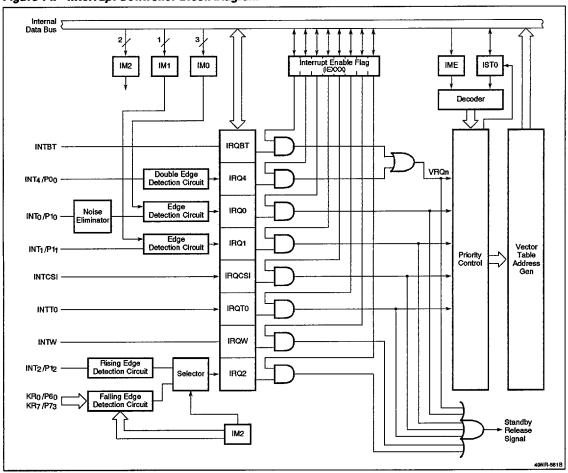
Interrupts

The µPD75316 family has a total of six interrupts (three external and three internal) that share five interrupt vectors. Refer to table 4 and figure 14.

Interrupts INTBT and INT4 share one interrupt vector and the interrupt to be serviced is determined by software in the interrupt service routine. In addition, INT2 detects the rising edge inputs and generates an interrupt request flag, which is testable. Inputs KR0-KR7 will detect falling edges and generate the same interrupt request flag as INT2.

Neither INT2 nor KR0-KR7 will cause a vectored interrupt, but they can be used to release the standby mode. Interrupt INTW also does not generate a vectored interrupt but can be tested and used to release the standby mode. All interrupts and interrupt requests except INTO will release the standby mode.

Figure 14. Interrupt Controller Block Diagram





Standby Modes

The three standby modes are described below and in table 5.

HALT Mode. The HALT mode is entered by executing the HALT instruction. In this mode, the clock to the CPU is shut off (thus stopping the CPU), while all other functions with the exception of INTO, remain fully operational.

STOP Mode. The STOP mode is entered by executing the STOP instruction. In this mode, the chip's main system oscillator is shut off, thereby stopping all functions except those which operate off the subsystem clock. If the subsystem clock is used, it always remains on.

The HALT and STOP modes are released by a RESET or by any interrupt request except INTO.

Data Retention Mode. This mode may be entered after entering the STOP mode. Here, supply voltage V_{DD} may be lowered to 2 volts to further reduce power consumption. The contents of the RAM and registers are retained. This mode is released by first raising V_{DD} to the proper operating range and then releasing the STOP mode.

Reset

Refer to table 6 for the state of the device after reset.

Table 4. Interrupt Sources

Interrupt Source	Operation	internal/ External	Interrupt Priority (Note)	Vectored Interrupt Request Signal(Vector Table Address)
INTBT	Reference time interval signal from basic interval timer	Internal	1	VRQ1 (0002H)
INT4	Both rising and falling edge detection	External	•	
INTO	Selection of rising or falling edge detection	External	2	VRQ2 (0004H)
INT1	Selection of rising or falling edge detection	External	3	VRQ3 (0006H)
INTCSI	Serial data transfer end signal	Internal	4	VRQ4 (0008H)
INTTO	Coincidence signal between programmable timer/event counter count register and modulo register	Internal	5	VRQ5 (000AH)
INT2	Rising edge detection of input to INT2 pin, or falling edge detection of any input to KR0-KR7	External	Testable input signal (can test if IRQ2 or IF	
INTW	Signal from watch timer	Internal	-	

Note: The interrupt priority determines the priority order when two or more interrupts are generated simultaneously.

μPD75316 Family



Table 5. Standby Mode Operation

Item	STOP Mode	HALT Mode		
Method of setting standby mode	STOP instruction by main clock or SCC register by subsystem clock	HALT instruction by main or subsystem clock		
Clock oscillator Only the main system clock oscillator is stopped		Only CPU clock $oldsymbol{\phi}$ is stopped (oscillation of main and subsystem clock continues)		
Basic interval timer	Operation stopped	Operational		
Serial interface	Operates only when external SCK input is selected for serial clock	Operational		
Timer/event counter	Operates only when TIO pin input is selected for count clock	Operational		
Watch timer	Operates only when fXT is selected for count clock	Operational		
LCD controller	Operates only when f _{XT} is selected by the watch timer	Operational		
External interrupts	INT1, INT2, INT4 can operate; INT0 cannot	INT1, INT2, INT4 can operate; INT0 cannot		
CPU	Operation stops	Operation stops		
Release signal Enabled interrupt request signal (except INTO) or RESET		Enabled interrupt request signal (except INT0) or RESET		

Table 6. State of the Device After Reset

н	ardware	RESET Input During Standby Mode	RESET Input During Operation		
Program counter (PC)	μPD75304		gram memory address 0000H are loaded nts of address 0001H are loaded into		
	μΡD75306 μΡD75308 μΡD75P308		gram memory address 0000H are loaded nts of address 0001H are loaded into		
	μPD75312 μPD75316 μPD75P316A	The low-order 6 bits of program memory address 0000H are into PC13 - PC8. The contents of address 0001H are loaded i PC7 - PC0.			
PSW	Carry flag (CY)	Held	Undefined		
	Skip flags (SK0 - SK2)	0	0		
	Interrupt status flag (IST0)	0	0		
	Memory bank enable flag (MBE)	Bit 7 of program memory address 0000H is loaded into MBE			
Stack pointer (SP)		Undefined	Undefined		
Data memory (RAM)		Held (Note 1)	Undefined		
General-purpose registers (X, A, H, L, D, E, B, C)		Held	Undefined		
Memory bank selection register (MBS)		0	0		
Basic interval timer	Counter (BT)	Undefined	Undefined		
	Mode register (BTM)	0	0		
Timer/event counter	Counter (T0)	0	0		
	Modulo register (TMOD0)	FFH	FFH		
	Mode register (TM0)	0	0		
	TOE0, TOUT F/F	0, 0	0, 0		



Table 6. State of the Device After Reset (cont)

1	Hardware	RESET Input During Standby Mode	RESET Input During Operation		
Watch timer	Mode register (WM)	0	0		
Serial interface	Shift register (SIO)	Held	Undefined		
	Operation mode register (CSIM)	0	0		
	SBI control register (SBIC)	0	0		
	Slave address register (SVA)	Held	Undefined		
Clock generator and clock output circuit	Processor clock control register (PCC)	0	0		
	System clock control register (SCC)	0	0		
	Clock output mode register (CLOM)	0	0		
LCD controller	Display mode register (LCDM)	0	0		
	Display control register (LCDC)	0	0		
Interrupt function	Interrupt request flags (IRQxxx)	Reset to 0	Reset to 0		
	Interrupt enable flags (IExxx)	0	0		
	Interrupt master enable flag (IME)	0	0		
	INTO, INT1, and INT2 and mode registers (IMO, IM1, and IM2)	0, 0, 0	0, 0, 0		
Digital ports	Output buffers	Off	Off		
	Output latches	Cleared to 0	Cleared to 0		
	Input/output mode registers (PMGA, B)	0	0		
	Pullup resistor specification register (POGA)	0	0		
Bit sequential buffer		Held	Undefined		
Pin conditions	P0 ₀ -P0 ₃ , P1 ₀ -P1 ₃ , P2 ₀ -P2 ₃ , P3 ₀ -P3 ₃ , P6 ₀ -P6 ₃ , P7 ₀ -P7 ₃	Input	Input		
	P4 ₀ P4 ₃ , P5 ₀ P5 ₃ ,	With incorporated pullup resistor, high level; with open drain, hi impedance			
	S0-S31 COM0-COM3	Note 2	Note 2		
BIAS		With incorporated resistor ladder, low level; with no incorporated resistor ladder, high impedance			

Notes:

- The data of data memory address 0F8H-0FDH is undefined by RESET.
- (2) S0 to S31 use V_{LC1}, COM0 to COM2 use V_{LC2}, and COM3 uses V_{LC0} as an input source. However, each display output level is based on each display output and V_{LCx}'s external circuit.

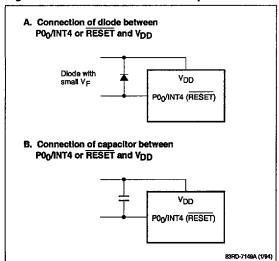


Caution

Apart from their normal functions, the P0₀/lNT4 and RESET pins are used to test the internal operation of the devices. The test mode is entered by applying a voltage greater than V_{DD} to either of these pins.

For this reason, care must be taken to limit the voltage applied to these two pins. For example, it is conceivable that even during normal operation enough spurious noise may be present to set the chip into the test mode. If this happens, further normal operation is impossible. Consequently, it is important that interwiring noise be suppressed as much as possible. If this is inconvenient, anti-noise measures, like those shown in figure 15, should be implemented.

Figure 15. Noise Reduction Techniques





ELECTRICAL SPECIFICATIONS

Absolute Maximum Ratings

IA = 25°C	
Supply voltage, V _{DD}	-0.3 to +7.0 V
Supply voltage, V _{PP} (75P308/ P316A)	-0.3 to +13.5 V
Input voltage, V _{I1} (other than ports 4, 5)	-0.3 to V _{DD} + 0.3 V
Input voltage, V ₁₂ (ports 4, 5; internal pullup resistor; 7530x/31x only)	-0.3 to V _{DD} + 0.3 V
input voltage, V _{I3} (ports 4, 5; open drain)	-0.3 to +11 V
Output voltage, V _O	-0.3 to V _{DD} + 0.3 V
High-level output current, I _{OH} (Single pin; standard grade)	-15 mA peak
High-level output current, I _{OH} (Single pin; special grade)	-10 mA peak
High-level output current, I _{OH} (Total of all pins)	-30 mA peak
Low-level output current, IOL	30 mA peak
(Single pin; standard grade)	15 mA rms †
Low-level output current, I _{OL}	10 mA peak
(Single pin; special grade)	5 mA rms †

Low-level output current, IOL	100 mA peak
(Total of ports 0, 2, 3, 5)	60 mA rms †
Low-level output current, I _{OL} (Total of ports 4, 6, 7; standard grade)	100 mA peak
	60 mA rms †
Low-level output current, I _{OL}	100 mA peak
(Total of ports 4, 6, 7; special grade)	50 mA rms †
Storage temperature, t _{STG}	−65 to + 150°C
Operating temperature, t _{OPT} (7530x/31x/P316A)	-40 to +85°C
Operating temperature, t _{OPT} (75P308)	-10 to +70°C
	. 15

† Rms value = peak value x (duty cycle) $^{1/2}$.

Exposure to Absolute Maximum Ratings for extended periods may affect device reliability; exceeding the ratings could cause permanent damage. The device should be operated within the limits specified under DC and AC characteristics.

Capacitance (All devices)

V_{DD} = 0 V; T_A = 25°C

Parameter	Symbol	Max	Unit	Conditions
Input capacitance	CIN	15	рF	f = 1 MHz;
Output capacitance	C _{OUT}	15	рF	all unmeasured pins returned
I/O capacitance	C _{IO}	15	рF	to ground

Main System Clock Oscillator

Refer to figures 16 and 18.

 μ PD7530x/31x/P316A: T_A = -40 to +85°C; V_{DD} = 2.7 to 6.0 V;

 μ PD75P308: T_A = -10 to +70°C; V_{DD} = 5 V ± 5%

Oscillator	Parameter	Symbol	Min	Тур	Max	Unit	Conditions
Ceramic resonator	Oscillation frequency (Note 1)	fx	1.0		5.0	MHz	
(Figure 16A)	Oscillation stabilization time (Note 2)				4 (Note 3)	ms	After V _{DD} reaches oscillator operating voltage
Crystal resonator	Oscillation frequency (Note 1)	fX	1.0	4.19	5.0	MHz	
(Figure 16A)	Oscillation stabilization time (Note 2)				10 (Note 3)	ms	$V_{DD} = 4.5 \text{ to } V_{DD} \text{ max}$
					30 (Note 3)	ms	$V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$ (7530x/31x/P316A)
External clock	X1 input frequency (Note 1)	fx	1.0		5.0	MHz	
(Figure 16B)	X1 input low- and high-level width	t _{XH} , t _{XL}	100		500	ns	

Notes:

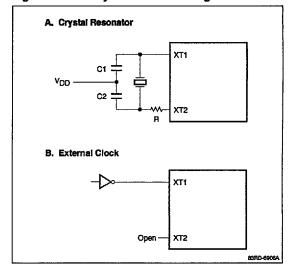
- (1) The oscillation frequency and X1 input frequency are shown only to present the characteristics of the oscillators. Refer to the AC Characteristics table for actual instruction execution times.
- (2) The oscillation stabilization time is the time required for the oscillator to stabilize after voltage is applied or the STOP mode is released.
- (3) Values shown are for the recommended resonators. Values for resonators not shown in this data sheet should be obtained from the manufacturer's spec sheets.



Figure 16. Main System Clock Configurations

A. Ceramic/Crystal Resonator X1 B. External Clock µPD74HCU04 X2 Note: When the Input is an external clock, the stop mode cannot be set because the X1 pin is connected internally to System ground (VSS). 83RD-7303A (10/93)

Figure 17. Subsystem Clock Configurations



Subsystem Clock Oscillator

Refer to figures 17 and 18.

 μ PD7530x/31x/P316A: T_A = -40 to +85°C; V_{DD} = 2.7 to 6.0 V; μ PD75P308: T_A = -10 to +70°C; V_{DD} = 5 V ± 5%

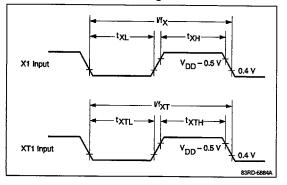
Oscillator	Parameter	Symbol	Min	Тур	Max	Unit	Conditions
Crystal resonator	Oscillation frequency	fxT	32	32.768	35	kHz	
(Figure 17A)	Oscillation stabilization			1.0	2	8	V _{DD} = 4.5 to V _{DD} max
	time (Note 1)				10	ş	V _{DD} = 2.7 to 6.0 V (7530x/31x/P316A)
External clock	XT1 input frequency	fхт	32		100	kHz	
(Figure 17B)	XT1 input low- and high-level width	[‡] ХТН ^{, ‡} ХТL	5		15	μs	

Note:

(1) Values shown are for recommended resonators. Values for resonators not in this data sheet should be obtained from the manufacturer's spec sheets.



Figure 18. Clock AC Timing Points X1 and XT1



Recommended Main System Ceramic Resonators (µPD7530x/31x Standard Grade Only)

Manufacturer	Part Number	C1 (pF)	C2 (pF)	Remarks
Murata	CSA 2.00MG093	15	15	V _{DD} = 2.5 to 3.5 V
	CSB 1000D20	220	220	V _{DD} = 2.7
	CSA 2.00MG093 CSA 4.19MGU CSA 4.91MGU	30 30 30	30 30 30	⁻ to 6.0 V
	CST 2.00MG093 CST 4.19MGU CST 4.91MGU	None None None	None None None	V _{DD} = 2.7 to 6.0 V (Note 1)
Kyocera	KBR-1000H	100	100	V _{DD} = 3.0
	KBR-2.0MS	68	68	to 6.0 V
	KBR-4.0MS KBR-4.19MS KBR-4.91MS	33 33 33	33 33 33	-

Note:

(1) C1 and C2 are contained in the oscillator.

Recommended Main System Crystal Resonators (μPD7530x/31x Standard Grade Only)

Manufacturer	Frequency (MHz)	Retainer	C1 (pF)	C2 (pF)	Remarks
Kinseki	2.00	HC-18/U	22	22	V _{DD} = 2.7
	4.19	HC-49/U	22	22	to 6.0 V
	4.91	HC-43/U	22	22	_

Recommended Subsystem Crystal Resonators (μPD7530x/31x Standard Grade)

Manufacturer	Туре	C1 (pF)	C2 (pF)	R (kΩ)	Remarks
Kinseki	P-3	22	22	330	$V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$

μPD75316 Family



DC Characteristics (μ PD7530x/31x/P316A) T_A = -40 to +85°C; V_{DD} = 2.7 to 6.0 V; refer to figures 19 through 22

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
High-level input voltage	V _{IH1}	0.7 V _{DD}		V _{DD}	٧	Ports 2, 3
	V _{IH2}	0.8 V _{DD}		۵۵V	٧	Ports 0, 1, 6, 7; and RESET
	V _{IH3}	0.7 V _{DD}	•	V _{DD}	V	Ports 4 and 5; internal pullup resistor, 7530x/ 31x
		0.7 V _{DD}		10	٧	Ports 4 and 5; open drain
	V _{IH4}	V _{DD} - 0.5		V _{DD}	ν	X1, X2, XT1
Low-level input voltage	V _{IL1}	0		0.3 V _{DD}	ν	Ports 2, 3, 4, 5
	V _{IL2}	0		0.2 V _{DD}	٧	Ports 0, 1, 6, 7; RESET
	V _{IL3}	0		0.4	٧	X1, X2, XT1
High-level output voltage	V _{OH1}	V _{DD} – 1.0			٧	Ports 0, 2, 3, 6, 7, BIAS; $V_{DD} = 4.5 \text{ to } 6.0 \text{ V};$ $I_{OH} = -1 \text{ mA}$
		V _{DD} - 0.5			٧	Ports 0, 2, 3, 6, 7, BIAS; $V_{DD} = 2.7$ to 6.0 V; $I_{OH} = -100 \ \mu A$
	V _{OH2}	V _{DD} - 2.0			٧	BP ₀₋₇ (with two I _{OH} outputs) V _{DD} = 4.5 to 6.0 V; I _{OH} = -100 μ A
		V _{DD} - 1.0			٧	BP ₀₋₇ (with two I_{OH} outputs) $V_{DD} = 2.7$ to 6.0 V; $I_{OH} = -30 \mu A$
Low-level output voltage	V _{OL1}		0.4	2.0	V	Ports 3, 4, 5; $V_{DD} = 4.5$ to 6.0 V; $I_{OL} = 15$ mA (standard grade)
			0.2	1.0	٧	Ports 3, 4, 5; V _{DD} = 4.5 to 6.0 V; I _{OL} = 5 mA (special grade)
				0.4	٧	Ports 0, 2-7; V _{DD} = 4.5 to 6.0 V; I _{OL} = 1.6 mA
				0.5	٧	Ports 0, 2-7; $V_{DD} = 2.7$ to 6.0 V; $I_{OL} = 400 \mu\text{A}$
				0.2 V _{DD}	٧	SB0, 1; $V_{DD} = 2.7$ to 6.0 V; open drain pullup resistance $\geq 1 k\Omega$
	V _{OL2}			1.0	٧	BP_{0-7} (with two I_{OL} outputs) $V_{DD} = 4.5$ to 6.0 V; $I_{OL} = 100 \mu A$
				1.0	٧	BP ₀₋₇ (with two I_{OL} outputs) $V_{DD} = 2.7$ to 6.0 V; $I_{OL} = 50 \mu A$
High-level input leakage current	l _{LIH1}	-		3	μΑ	All except X1, X2, XT1 and ports 4, 5 (open drain); $V_{IN} = V_{DD}$
	I _{LIH2}			20	μΑ	X1, X2, and XT1; V _{IN} = V _{DD}
	I _{LIH3}			20	μΑ	Ports 4 and 5 (with open drain); $V_{IN} = 10 \text{ V}$
Low-level input leakage current	I _{LIL1}			-3	μА	All except X1, X2, and XT1; V _{IN} = 0 V
	I _{LIL2}			-20	μА	X1, X2, and XT1; $V_{IN} = 0 V$
High-level output leakage current	I _{LOH1}			3	μА	Other than ports 4 and 5 (open drain); $V_{OUT} = V_{DD}$
	I _{LOH2}			20	μΑ	Ports 4 and 5 (open drain); V _{OUT} = 10 V
Low-level output leakage current	LOL			-3	μΑ	V _{OUT} = 0 V



DC Characteristics (µPD7530x/31x/P316A) (cont)

Parameter	Symbol		Min	Тур	Max	Unit	Conditions
Internal pullup resistor	A _{L1}		15	40	80	kΩ	Ports 0-3, 6, 7 (except PO ₀); $V_{IN} = 0 V$; $V_{DD} = 5.0 V \pm 10\%$
			30		200	kΩ	Ports 0-3, 6, 7 (except PO ₀); $V_{IN} = 0 V$; $V_{DD} = 3.0 V \pm 10\%$; $7530x/31x$
			30		300	kΩ	Ports 0-3, 6, 7 (except P0 ₀); $V_{IN} = 0 \text{ V}$; $V_{DD} = 3.0 \text{ V} \pm 10\%$; 75P316A
	R _{L2}		15	40	70	kΩ	Ports 4, 5; $V_{OUT} = V_{DD} - 2 V$; $V_{DD} = 5.0 V \pm 10\%$; 7530x/31x
			10		60	kΩ	Ports 4, 5; $V_{OUT} = V_{DD} - 2 V$; $V_{DD} = 3.0 V \pm 10\%$; $7530x/31x$
LCD drive voltage	VLCD		2.5		V _{DD}	٧	
LCD split resistor	R _{LCD} (Note 1)		60	100	150	kΩ	7530x/31x
LCD output voltage deviation; common (Note 2)	V _{ODC}		0		±0.2	٧	$I_O = \pm 5 \mu A;$ $V_{LCD} = V_{LCD0} = 2.7 V \text{ to } V_{DD};$ $V_{LCD1} = 2/3 V_{LCD}$ $V_{LCD2} = 1/3 V_{LCD}$
LCD output voltage deviation; segment (Note 2)	Vods		0		±0.2	٧	$\begin{array}{l} I_{O} = \pm 1 \; \mu A; \\ V_{LCD} = V_{LCD0} = 2.7 \; V \; to \; V_{DD}; \\ V_{LCD1} = 2/3 \; V_{LCD} \\ V_{LCD2} = 1/3 \; V_{LCD} \end{array}$
Supply current (Note 3)	I _{DD1} (Note 4)	† ‡		2.5 4.5	8 14	mA mA	V _{DD} = 5 V ±10% (Note 5)
		† ‡		0.35 0.9	1.2 3	mA mA	V _{DD} = 3 V ±10% (Note 6)
	I _{DD2} (Note 4)	† ‡		500 700	1500 2100	μA μA	HALT mode; $V_{DD} = 5 \text{ V } \pm 10\%$
		† ‡		150 300	450 900	μA μA	HALT mode; V _{DD} = 3 V ±10%
	I _{DD3} (Note 7)	† ‡		30 100	90 300	μA μA	V _{DD} = 3 V ±10% (Note 8)
	I _{DD4} (Note 7)	† ‡		5 20	15 60	μA μA	HALT mode; V _{DD} = 3 V ±10% (Note 8)
	I _{DD5}			0.5	20	μΑ	STOP mode; XT1 = 0 V; V _{DD} = 5 V ±10%
				0.1	10	μΑ	STOP mode; XT1 = 0 V; V _{DD} = 3 V ±10%
				0.1	5	μΑ	STOP mode; XT1 = 0 V; V_{DD} = 3 V ±10%; T_A = 25°C
	I _{DD6} (Note 7)	‡		5	15	μΑ	STOP mode; 3 V ±10%; (Note 9: 75P316A)

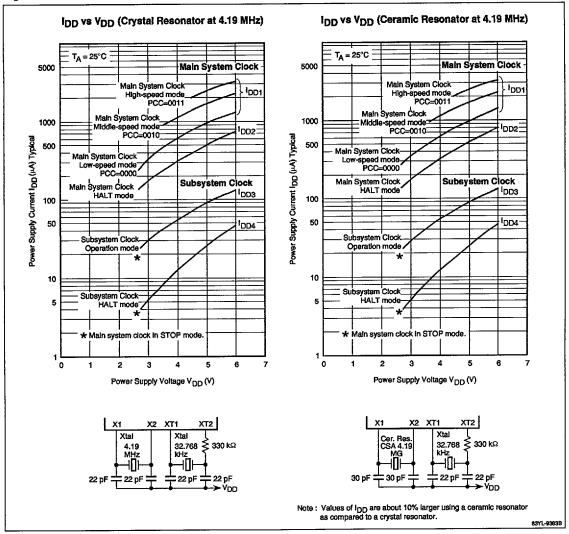
Notes:

- LCD split resistor is a mask option. See LCD Drive Power Supply section in the user's manual. R = R_{LCD}.
- (2) Voltage deviation is the difference between the ideal value of segment or common output (V_{LCDn}; n = 0, 1, 2) and the output voltage.
- (3) Does not include internal pullup resistor current and current through LCD resistor ladder.
- (4) 4.19-MHz crystal oscillator; (C1 = C2 = 22 pF); subsystem clock running.
- (5) When operated in the high-speed mode with the processor clock control register (PCC) set to 0011.

- (6) When operated in the low-speed mode with the PCC set to 0000.
- (7) 32-kHz crystal oscillator
- (8) Main system clock stopped and subsystem clock running (SCC = 1001).
- (9) When STOP instruction is executed during main system clock operation and the subsystem clock is oscillating.



Figure 19. DC Characteristics, IDD vs VDD (#PD7530x/31x, Standard Grade) (Sheet 1 of 2)

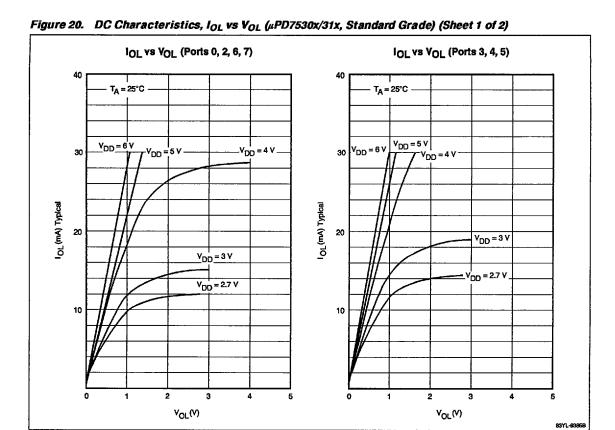




I_{DD} vs V_{DD} (Ceramic Resonator at 1.00 MHz) IDD vs VDD (Ceramic Resonator at 2.00 MHz) _T_A = 25°C TA = 25°C 5000 5000 Main System Clock Main System Clock Main System Clock Main System Clock IDD1 IDD1 High-speed mode PCC=0011 High-speed mode PCC=0011 1000 1000 Main System Clock DD2 DD2 Middle-speed mode PCC=0010 Power Supply Current IDD (µA) Typical Power Supply Current I_{DD} (µA) Typical Main System Clock 500 500 Middle-speed mode PCC=0010 Main System Clock Low-speed mode PCC=0000 Main System Clock 4 Subsystem Clock Low-speed mode PCC=0000 Subsystem Clock IDD3 Main System Clock 100 100 Main System Clock 2 HALT mode HALT mode 50 l_{DD4} 50 DD4 Subsystem Clock Operation mode Subsystem Clock Operation mode * 10 10 Subsystem Clock 5 5 Subsystem Clock HALT mode * * Main system clock in STOP mode. ★ Main system clock in STOP mode. 6 0 Power Supply Voltage V_{DD} (V) Power Supply Voltage V_{DD} (V) X2 XT1 X1 XT2 X2 XT1 XT2 **Xtal** Cer. Res. CSB1000 Cer. Res. CSA 2.00 32.768 ≸ 330 kΩ 32.768 **₹** 330 kΩ kHz kHz D20 ⊣∏⊦ **〒22 pF** 22 pF 30 pF 22 pF 22 pF **→**V_{DD} 83YL-9384B

Figure 19. DC Characteristics, I_{DD} vs V_{DD} ($\mu PD7530x/31x$, Standard Grade) (Sheet 2 of 2)





VOL(V)



I_{OL} vs V_{OL} (BP0 - 3, BP4 - 7) I_{OL} vs V_{OL} (BP0 - 3, BP4 - 7) ν_{DD} = 3 ν **V**_{DD} = 5 **V** 250 800 T_A = 25°C TA = 25°C * Number of * Number of concurrent concurrent outputs: 1 outputs: 700 200 600 500 150 2 l_{OL} (μΑ) Typical I_{OL} (μA) Typical 2 400 3 3 100 300 4 4 200 50 Of pins BP0 to BP3 or BP4 * Of pins BP0 to BP3 or BP4 100 to BP7, number of pins outputting the same level. to BP7, number of pins outputting the same level. 2 3 2 1

Figure 20. DC Characteristics, IOL vs VOL (#PD7530x/31x, Standard Grade) (Sheet 2 of 2)

VOL (V)

83YL-9386B



Figure 21. DC Characteristics, I_{OH} vs V_{DD} – V_{OH} (μ PD7530x/31x, Standard Grade) (Sheet 1 of 2)

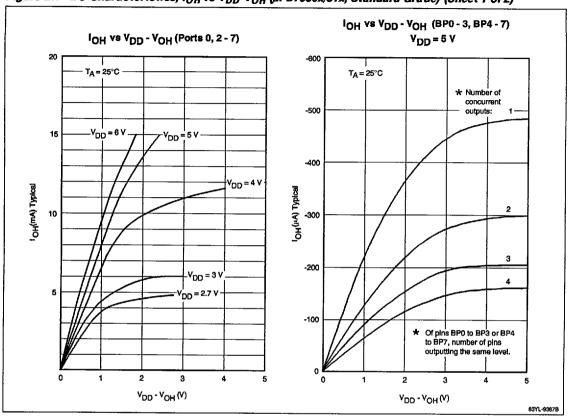




Figure 21. DC Characteristics, I_{OH} vs V_{DD}-V_{OH} (μPD7530x/31x, Standard Grade) (Sheet 2 of 2)

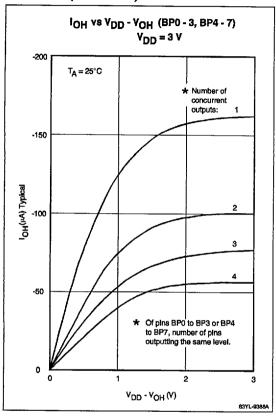
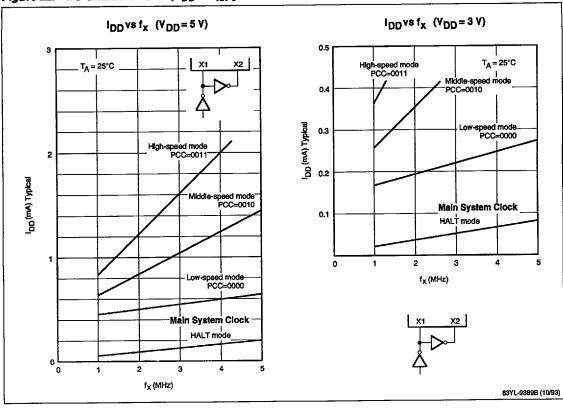




Figure 22. DC Characteristics, I_{DD} vs $f_{\chi\chi}$ ($\mu PD7530x/31x$, Standard Grade)





AC Characteristics (μPD7530x/31xP316A)

 $T_A = -40 \text{ to } +85^{\circ}\text{C}$; $V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$; refer to figures 23 through 27

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
Cycle time	tcY	0.95		64	μs	Main system clock; V _{DD} = 4.5 to 6.0 V
(Note 1)	(figure 24)	3.8		64	μs	Main system clock; V _{DD} = 2.7 to 6.0 V
		114	122	125	μs	Subsystem clock
10 input frequency	f _{TI}	0		1	MHz	V _{DD} = 45 to 6.0 V
	(figure 25)	0		275	kHz	V _{DD} = 2.7 to 6.0 V
TIO input high-and low-level width	tTIH, tTIL	0.48			μз	V _{DD} = 4.5 to 6.0 V
	(figure 25)	1.8			μs	V _{DD} = 2.7 to 6.0 V
Interrupt inputs high-and low-level width	tINTH, TINTL	(Note 2)			μs	INTO
mgr-and low-level width	(figure 26)	10			μs	INT1, 2, 4
		10			μs	KR0-KR7
RESET low-level width	t _{RSL} (figure 27)	10		_	μs	After V _{DD} ≥ 2.7 V

- (1) Cycle time (minimum instruction execution time) is determined by the frequency of the oscillator connected to the microcomputer, system clock control register (SCC), and the processor clock control (PCC). See figure 24.
- (2) 2t_{CY} or 128/f_X, depending on the setting of the interrupt mode register (IMO).



Figure 23. AC Timing Measurement Points (except X1 and XT1)

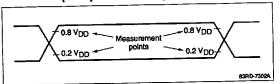


Figure 24. Main System Clock Operation; t_{CY} vs V_{DD} (μ PD7530x/31x/P316A)

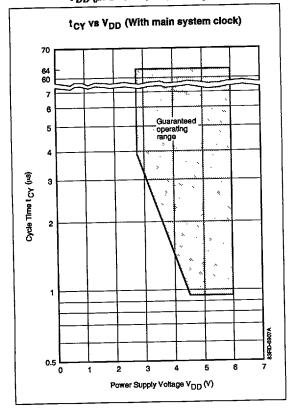


Figure 25. TIO Timing

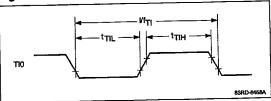


Figure 26. Interrupt Input Timing

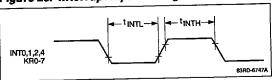
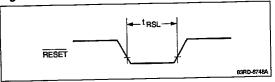


Figure 27. RESET Input Timing





Serial Interface, 2/3-Line Serial I/O Mode; Internal SCK Output (μPD7530x/31x/P316A)

 $T_A = -40 \text{ to } +85^{\circ}\text{C}; V_{DD} = 2.7 \text{ to } 6.0 \text{ V}; \text{ refer to figure } 28$

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
SCK cycle time	t _{KCY1}	1600			ns	V _{DD} = 4.5 to 6.0 V
		3800			пѕ	$V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$
SCK high- and low-level width	t _{KH1} , t _{KL1}	0.5 t _{KCY1} - 50			пѕ	$V_{DD} = 4.5 \text{ to } 6.0 \text{ V}$
		0.5 t _{KCY1} - 150			пѕ	$V_{DD} = 27 \text{ to } 60 \text{ V}$
SI setup time to SCK †	tsiK1	150			ns	
SI hold time from SCK †	^t KSI1	400			ns	
SCK ↓ to SO output delay time	^t KSO1			250	ns	$V_{DD} = 4.5 \text{ to 6.0 V (Note)}$
				1000	ns	V _{DD} = 2.7 to 6.0 V (Note)

Note: R $_L=1~k\Omega$ and $C_L=100~pf$ are load resistance and load capacitance for the SO line.

Serial Interface, 2/3-Line Serial I/O Mode; External SCK Input (μPD7530x/31x/P316A)

 $T_A = -40 \text{ to } +85^{\circ}\text{C}$; $V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$; refer to figure 28

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
SCK cycle time	t _{KCY2}	800			ns	$V_{DD} = 4.5 \text{ to } 6.0 \text{ V}$
		3200			ns	$V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$
SCK high- and low-level width	tKH2, tKL2	400			ns	V _{DD} = 4.5 to 6.0 V
		1600			ns	$V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$
SI setup time to SCK †	tsık2	100			ns	
SI hold time from SCK †	t _{KSI2}	400			ns	
SCK ↓ to SO output delay time	tkso2			300	ns	$V_{DD} = 4.5 \text{ to } 6.0 \text{ V (Note)}$
				1000	пѕ	V _{DD} = 2.7 to 6.0 V (Note)

Note: $R_L=1~k\Omega$ and $C_L=100~pf$ are load resistance and load capacitance for the SO line.



Serial Interface, SBI Mode; Internal SCK Output (Master) (µPD7530x/31x/P316A)

 $T_A = -40 \text{ to } +85^{\circ}\text{C}$; $V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$; refer to figure 28

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
SCK cycle time	t _{KCY3}	1600			ns	$V_{DD} = 4.5 \text{ to } 6.0 \text{ V}$
		3800			ns	$V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$
SCK high- and low-level width	[†] КНЗ ^{, †} КLЗ	0.5 t _{KCY3} - 50			ns	$V_{DD} = 4.5 \text{ to } 6.0 \text{ V}$
		0.5 t _{KCY3} - 150			ns	$V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$
SB0, SB1 setup time to SCK †	t _{s1K3}	150			ns	
SB0, SB1 hold time from SCK †	t _{KS13}	0.5 t _{KCY3}			ns	
SCK ↓ to SB0, SB1 output delay time	t _{KSO3}	0		250	ns	V _{DD} = 4.5 to 6.0 V (Note)
		0		1000	ns	$V_{DD} = 2.7 \text{ to } 6.0 \text{ V (Note)}$
SCK † to SB0, SB1 ↓	t _{KSB}	t _{KCY3}			ns	
SB0, SB1 ∔ to SCK ∔	tsBK	tксуз			ns	
SB0, SB1 low-level width	†SBL	t _{KCY3}			ns	
SB0, SB1 high-level width	^t sBH	t _{KCY3}			пѕ	

Note: $R_L=1~k\Omega$ and $C_L=100~pf$ are load resistance and load capacitance for the SB0, SB1 output lines.

Serial Interface, SBI Mode; External SCK Input (Slave) (µPD7530x/31x/P316A)

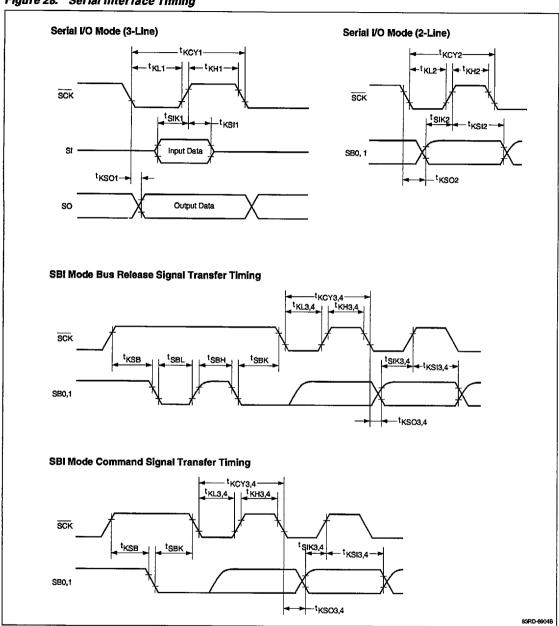
 $T_A = -40 \text{ to } +85^{\circ}\text{C}$; $V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$; refer to figure 28

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
SCK cycle time	t _{KCY4}	800			пѕ	V _{DD} = 4.5 to 6.0 V
		3200			пѕ	$V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$
SCK high- and low-level width	t _{KH4} , t _{KL4}	400			ns	V _{DD} = 4.5 to 6.0 V
		1600			пѕ	$V_{DD} = 2.7 \text{ to } 6.0 \text{ V}$
SB0, SB1 setup time to SCK †	tsiK4	100			ns	
SB0, SB1 hold time from SCK t	t _{KS14}	0.5 t _{KCY4}			ns	
SCK ↓ to SB0, SB1 output delay time	[†] KSO4	0		300	ns	V _{DD} = 4.5 to 6.0 V (Note)
		0		1000	ns	V _{DD} = 2.7 to 6.0 V (Note)
SCK f to SB0, SB1 ↓	t _{KSB}	t _{KCY4}			ns	
SB0, SB1 ↓ to SCK ↓	^t \$BK	[†] KCY4			ns	
SB0, SB1 low-level width	t _{SBL}	[†] KCY4			ns	
SB0, SB1 high-level width	t _{SBH}	t _{KCY4}			ns	

Note: R_L = 1 k Ω and C_L = 100 pf are load resistance and load capacitance for the SB0, SB1 output lines.



Figure 28. Serial Interface Timing





Data Memory STOP Mode; Low-Voltage Data Retention Characteristics

 $T_A = -40 \text{ to } +85^{\circ}\text{C}$; refer to figure 29

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
Data retention voltage	V _{DDDR}	2.0		6.0	٧	
Data retention current (Note 1)	IDDDR		0.1	10	μА	$V_{DDDR} = 2.0 \text{ V; } XT1 = 0$
Release signal set time	tsrel	0			μs	
Oscillation stabilization time (Note 2)	twarr		(Notes 3, 4)		ms	Release by RESET input
			(Note 3)		ms	Release by interrupt reques

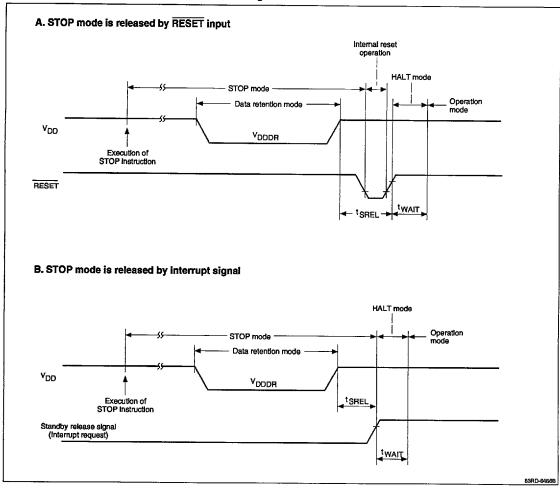
- (1) Excludes current in the internal pullup resistors and LCD resistor
- (2) Oscillation stabilization WAIT time is the time during which the CPU is stopped and the crystal is stabilizing. This time is required to prevent unstable operation while the oscillation is started. The interval timer can be used to delay the CPU from executing instructions using the basic interval timer mode register (BTM) according to the following table:

втмз	BTM2	BTM1	втмо	WAIT Time (f _x = 4.19 MHz)
-	0	0	0	2 ²⁰ /f _x (250 ms approx)
-	0	1	1	2 ¹⁷ /f _X (31.3 ms approx)
_	1	0	1	2 ¹⁵ /f _x (7.82 ms approx)
_	1	1	1	2 ¹³ /f _x (1.95 ms approx)

- (3) Consult the manufacturer's resonator or crystal specification sheet for this value.
- (4) The interval timer will cause a delay of $2^{17}/f_{\chi}$ after a reset.



Figure 29. Low-Voltage Data Retention Timing





Recommended Ceramic Resonators $(\mu PD75P308)$ $V_{DD} = 4.75 \text{ to } 5.25 \text{ V}; T_A = -10 \text{ to } +70^{\circ}\text{C}$

Manufacturer	Part Number	C1 (pF)	C2 (pF)	Remarks
Murata	CSA 2.00MG	30	30	
	CSA 4.19MG	30	30	
	CSA 4.91MGU	30	30	
	CST 4.19MG	(Note)	(Note)	

Note: 30 pF capacitors are internally provided.

DC Characteristics (µPD75P308)

 $T_{A} = -10 \text{ to } +70^{\circ}\text{C} \cdot \text{Vpp} = 5 \text{ V} \pm 5\%$

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
High-level input voltage	V _{IH1}	0.7 V _{DD}		V _{DD}	V	Ports 2, 3
		0.8 V _{DD}		V _{DD}	٧	Ports 0, 1, 6, 7; RESET
	V _{IH3}	0.7 V _{DD}		10	٧	Ports 4, 5; open drain
	V _{IH4}	V _{DD} - 0.5		V _{DD}	٧	X1, X2, XT1
Low-level input voltage	V _{IL1}	0		0.3 V _{DD}	٧	Ports 2, 3, 4, 5
	V _{IL2}	0		0.2 V _{DD}	٧	Ports 0, 1, 6, 7, RESET
	V _{IL3}	0		0.4	٧	X1, X2, XT1
High-level output voltage	V _{OH1}	V _{DD} – 1.0			٧	Ports 0, 2, 3, 6, 7, BIAS; I _{OH} = -1 mA
•	V _{OH2}	V _{DD} - 2.0			٧	BP_{0-7} ; $I_{OH} = -100 \mu\text{A}$ (Note 1)
Low-level output voltage	V _{OL1}		0.4	2.0	٧	Ports 3, 4, 5; I _{OL} = 15 mA
				0.4	V	All output pins; I _{OL} = 1.6 mA
	V _{OL2}			0.2 V _{DD}	٧	SB0, SB1; open drain pullup resistor ≥ 1kΩ
	V _{OL3}			1.0	٧	BP_{0-7} ; $I_{OL} = 100 \mu\text{A}$ (Note 1)
High-level input leakage current	I _{LIH1}			3	μΑ	All except X1, X2, and XT1; V _{IN} = V _{DD}
•	ILIH2			20	μΑ	X1, X2, and XT1; V _{IN} = V _{DD}
	ILIH3			20	μA	Ports 4 and 5; V _{IN} = 10 V
Low-level input leakage current	ILIL1			-3	μА	All except X1, X2, and XT1; V _{IN} = 0 V
	1 _{LIL2}			20	μΑ	X1, X2, and XT1; V _{IN} = 0 V
High-level output leakage current	I _{LOH1}			3	μΑ	All output pins except ports 4, 5; V _{OUT} = V _{DI}
•	I _{LOH2}			20	μΑ	Ports 4, 5; V _{OUT} = 10 V
Low-level output leakage current	ILOL			-3	μΑ	V _{OUT} = 0 V
Internal pullup resistor	RLI	15	40	80	kΩ	Ports 0-3, 6, 7 (except PO ₀); V _{IN} = 0 V
LCD drive voltage	VLCD	2.5		V _{DD}	٧	
LCD output voltage deviation; common (Note 7)	V _{ODC}	0		±0.2	٧	$I_{O} = \pm 5 \mu A;$ $V_{LCD} = V_{LCD0} = 2.7 V \text{ to } V_{DD};$ $V_{LCD1} = 2/3 V_{LCD}$ $V_{LCD2} = 1/3 V_{LCD}$
LCD output voltage deviation; segment (Note 7)	V _{ODS}	o		±0.2	٧	$I_{O} = \pm 1 \mu A;$ $V_{LCD} = V_{LCD0} = 2.7 \text{ V to } V_{DD};$ $V_{LCD1} = 2/3V_{LCD}$ $V_{LCD2} = 1/3V_{LCD}$



DC Characteristics (µPD75P308) (cont)

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
Supply current	I _{DD1}		5.0	15.0	mA	(Notes 3, 4)
(Note 2)	I _{DD2}		500	1500	μΑ	HALT mode (Note 3)
	1 _{DD3}		350	1000	μΑ	(Notes 5, 6)
			35	100	μΑ	HALT mode (Notes 5, 6)
	I _{DD4}	-	0.5	20	μΑ	STOP mode; XT1 = 0 V

Notes:

- When any two pins of BP0-BP3 or any two pins of BP4-BP7 are used simultaneously for output.
- (2) Does not include pullup resistor current.
- (3) 4.19-MHz crystal oscillator; C1 = C2 = 22 pF; subsystem clock running.
- (4) Value during high-speed operation and the processor control clock (PCC) is set to 0011.
- (5) Value when the system clock control register (SCC) is set to 1001; generation of the main system clock pulse is stopped, and the SCC is operated by the subsystem clock.
- (6) 32-kHz crystal oscillator.
- (7) Voltage deviation is the difference between the ideal value of segment or common output (V_{LCDn}; n = 0, 1, 2) and the output voltage.

AC Characteristics (μPD75P308)

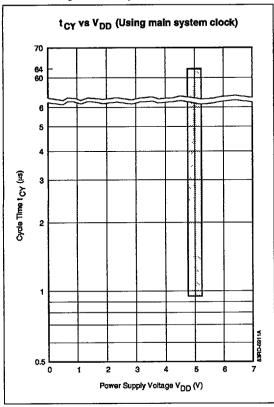
 $T_A = -10 \text{ to } +70^{\circ}\text{C}; V_{DD} = 5 \text{ V } \pm 5\%; \text{ refer to figure 30}$

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
Cycle time	tcY	0.95		64	μs	Main system clock
(minimum instruction execution time, Note 1)	(figure 29)	114	122 125 μs	μs	Subsystem clock	
TIO input frequency	f _{T1} (figure 24)	0		1	MHz	
TIO input high- and low-level width	t _{TIH} , t _{TIL} (figure 24)	0.48			μs	
Interrupt inputs	tinth, tintl	(Note 2)			μs	INTO
high- and low-level width	(figure 25)	10			μs	INT1, INT2, INT4 KR0-KR7
RESET low-level width	t _{RSL} (figure 26)	10			μs	After V _{DD} ≥ 4.75 \

- Cycle time is determined by the frequency of the oscillator connected to the microcomputer, system clock control register (SCC), and the processor clock control (PCC).
- (2) 2t_{CY} or 128/f_x, depending on the setting of the interrupt mode register (IMO).



Figure 30. Guaranteed Operating Range (#PD75P308)



Serial Interface, 2/3-Line Serial I/O Mode; Internal \overline{SCK} Output (μ PD75P308) $T_A = -10 \text{ to } +70^{\circ}\text{C}$; $V_{DD} = 5 \text{ V} \pm 5\%$; refer to figure 28

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
SCK cycle time	t _{KCY1}	1600			ns	Output
SCK high- and low-level width	t _{KH1} , t _{KL1}	0.5 t _{KCY1} - 50			ns	Output
SI setup time (against SCK †)	t _{SIK1}	150			ns	
SI hold time (against SCK f)	t _{KSI1}	400			ns	
SCK ↓ to SO output delay time	t _{KSO1}			250	ns	



Serial Interface, 2/3-Line Serial I/O Mode; External SCK Input (µPD75P308)

 $T_A = -10 \text{ to } +70^{\circ}\text{C}; V_{DD} = 5 \text{ V } \pm 5\%; \text{ refer to figure 28}$

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
SCK cycle time	tKCY2	800			ns	Input
SCK high- and low-level width	tKH2, tKL2	400			ns	Input
SI setup time (to SCK †)	tsik2	100			ns	
SI hold time (from SCK f)	t _{KSI2}	400			пѕ	
SCK ↓ to SO output delay time	t _{KSO2}			300	пѕ	

Serial Interface, SBI Mode; Internal SCK Output (Master) (µPD75P308)

 $T_A = -10 \text{ to } +70^{\circ}\text{C}; V_{DD} = 5 \text{ V} \pm 5\%; \text{ refer to figure 28}$

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
SCK cycle time	t _{KCY3}	1600			пѕ	
SCK high- and low-level width	t _{KH3} , t _{KL3}	0.5 t _{KCY3} - 50			ns	
SB0, SB1 setup time to SCK †	tsik3	150			ns	
SB0, SB1 hold time from SCK †	t _{KSI3}	0.5 t _{KCY3}			ns	
SCK ↓ to SB0, SB1 output delay time	t _{KSO3}	0		250	ns	
SCK↑ to SB0, SB1 ↓	†KSB	t _{KCY3}			ns	
SB0, SB1 ↓ to SCK ↓	[†] SBK	t _{KCY3}		-	ns	
SB0, SB1 low-level width	^t s8L	t _{KCY3}			ns	
SB0, SB1 high-level width	tsвн	t _{KCY3}			ns	

Serial Interface, SBI Mode; External SCK Input (Slave) (μPD75P308)

 $T_A = -10 \text{ to } +70^{\circ}\text{C}; V_{DD} = 5 \text{ V } \pm 5\%; \text{ refer to figure } 28$

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
SCK cycle time	tKCY4	800			ns	
SCK high- and low-level width	tKH4, tKL4	400			ns	
SB0, SB1 setup time to SCK †	tsik4	100			ns	
SB0, SB1 hold time from SCK †	t _{KS14}	0.5 t _{KCY4}			ns	
SCK ↓ to SB0, SB1 output delay time	^t KSO4	0		300	ns	
SCK↑ to SB0, SB1 ↓	^t KSB	t _{KCY4}			ns	
SB0, SB1 ↓ to SCK ↓	tsвк	t _{KCY4}			ns	
SB0, SB1 low-level width	t _{SBL}	t _{KCY4}			ns	
SB0, SB1 high-level width	t _{SBH}	t _{KCY4}			ns	



PROM PROGRAMMING

The PROM in the μ PD75316 family is one-time programmable (OTP) or ultraviolet erasable (UVE). In the μ PD part numbers below, GF and K denote QFP and LCC packages, respectively.

μPD	PROM	Bytes	Package
75P308GF	ОТР	8064	QFP
75P308K	UVE	8064	LCC w/window
75P316AGF	OTP	16,256	QFP
75P316AK	UVE	16,256	LCC w/window

The PROM is programmed using the pins listed in table 7. Note that it is not necessary to enter an address since the address is updated by pulsing the clock pins. During programming, addresses are incremented by applying clock pulses to the X1 and X2 input pins. When ± 6 V is applied to V_{DD} and ± 12.5 V to V_{PP} , the PROM is placed in the write/verify mode. Pins MD0 - MD3 select the applicable operation as shown in table 8.

Table 7. PROM Write and Verify Pin Functions

Idolo 7. Tilom	mile and rormy rain andirone			
Pin	Function			
X1, X2	Pulsed to increment address during PROM write/verify operation. The inverse of X1 is applied to X2. Note that these pins are also pulsed during a read.			
MD0 - MD3	Operation mode selection pins.			
P4 ₀ - P4 ₃ (four low-order bits) P5 ₀ - P5 ₃ (four high-order bits)	8-bit data input/output pins for write/verify			
V _{DD}	Supply voltage. Normally 5 volts; 6 volts is applied during write/verify			
V _{PP}	Normally 5 volts; 12.5 volts is applied during write/verify			

Note: To prevent erasure, the window on the ceramic LCC package of the 75P308K/316AK should be covered with an opaque film. Since the μPD75P308GF/P316GFAGF do not have windows, the contents of their EPROM cannot be erased.

Table 8. Mode Selection

 $V_{PP} = +12.5 \text{ V}; V_{DD} = +6.0 \text{ V}$

MD1	MD2	MD3	Operation Mode
0	1	0	Program memory address clear
1	1	1	Write mode
0	1	1	Verify mode
х	1	1	Program inhibit
	0	0 1 1	0 1 0

x = Don't care.

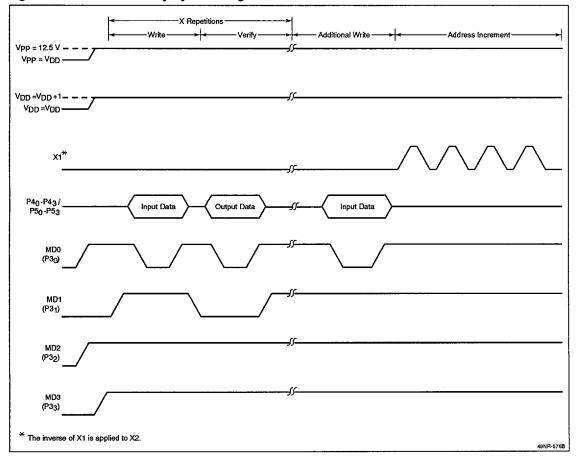
PROM Write/Verify Procedure

PROMs can be written at high speed using the following procedure. Figure 31 is the timing diagram.

- (1) Connect unused pins to V_{SS} through resistors. Set the X1 pin low.
- (2) Supply +5 volts to V_{DD} and V_{PP} pins.
- (3) Wait 10 μs.
- (4) Select program memory address clear mode.
- (5) Supply +6 volts to V_{DD} pin and + 12.5 volts to V_{PP} pin.
- (6) Select program inhibit mode.
- (7) Write data in the 1-ms write mode.
- (8) Select program inhibit mode.
- (9) Select verify mode. If data is correct, proceed to step 10. If not, repeat steps 7, 8, and 9 up to a maximum of 20 times. If data is still incorrect, terminate programming and declare the device defective.
- (10) Perform one additional write with an MD0 pulse width (in ms) equal to the number of writes performed in step 7. For example, MD0 = 10 ms if the location was written to 10 times in step 7.
- (11) Select program inhibit mode.
- (12) Apply four pulses to the X1 pin to increment the program memory address by one.
- (13) Repeat steps 7-12 until the end address is reached.
- (14) Select program memory address clear mode.
- (15) Return V_{DD} and V_{PP} pins to +5 volts.
- (16) Turn off power.



Figure 31. PROM Write/Verify Cycle Timing





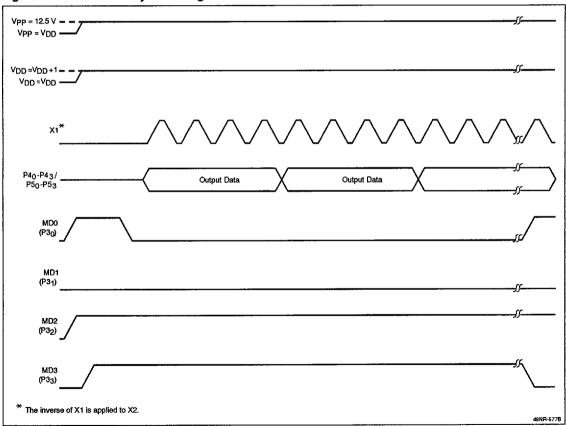
PROM Read Procedure

The PROM contents can be read by using the following procedure. Figure 32 is the timing diagram for steps 2-9.

- (1) Connect unused pins to V_{SS} through resistors. Set the X1 pin low.
- (2) Supply +5 volts to V_{DD} and V_{PP} pins.
- (3) Wait 10 µs.
- (4) Select program memory address clear mode.
- (5) Supply +6 volts to V_{DD} pin and +12.5 volts to V_{PP} pin.

- (6) Select program inhibit mode.
- (7) Select verify mode. Apply four pulses to the X1 pin. The data in address 0 will be output. Every additional four clock pulses will output the data stored in the next address.
- (8) Select program inhibit mode.
- (9) Select program memory address clear mode.
- (10) Return VDD and VPP pins to +5 volts.
- (11) Turn off power.

Figure 32. PROM Read Cycle Timing





Program Erasure (μPD75P308K/P316AK)

The UVE PROM (EPROM) can be erased by light rays whose wavelength is shorter than about 250 nm. The programmed data contents may also be erased if the uncovered window is exposed to direct sunlight or a fluorescent light for several hours. Thus, to protect the data contents, cover the window with an opaque film. NEC attaches quality-tested shading film to the UVE PROM products for shipping.

For normal EPROM erasure, place the device under an ultraviolet light source (254 nm). The minimum radiation exposure required to erase the written data completely is 15 Ws/cm² (ultraviolet ray strength times erase time). This corresponds to about 15 to 20 minutes with a a UV lamp of 12,000 μ W/cm². However, the time may be prolonged if the UV lamp is old or if the device window is dirty. The distance between the light source and the window should be 2.5 cm or less.

DC Programming Characteristics (μPD75P308/P316A)

 $T_A = 25 \pm 5^{\circ}C; V_{DD} = 6.0 \pm 0.25 V; V_{PP} = 12.5 \pm 0.3 V; V_{SS} = 0 V$

Parameter	Symbol	Min	Тур	Max	Unit	Conditions
High-level input voltage	V _{IH1}	0.7 V _{DD}	•	V _{DD}	٧	All except X1, X2
	V _{IH2}	V _{DD} - 0.5		V _{DD}	٧	X1, X2
Low-level input voltage	V _{IL1}	0		0.3 V _{DD}	٧	All except X1, X2
	V _{IL2}	0		0.4	٧	X1, X2
Input leakage current	lLI			10	μΑ	VIN = VIL or VIH
High-level output voltage	V _{OH}	V _{DD} – 1.0			٧	I _{OH} = -1 mA
Low-level output voltage	V _{OL}			0.4	٧	l _{OL} = 1.6 mA
V _{DD} supply current	IDD			30	mA	
V _{PP} supply current	I _{PP}			30	mA	$MD0 = V_{IL}; MD1 = V_{IH}$

- (1) Vpp must not exceed +13.5 V, including overshoot.
- (2) V_{DD} must be applied before V_{PP} . V_{DD} should be removed after V_{PP} is removed.

μPD75316 Family



AC Programming Characteristics (μPD75P308/P316A)

 $T_A = 25 \pm 5^{\circ}C$; $V_{DD} = 6.0 \pm 0.25 \text{ V}$; $V_{PP} = 12.5 \pm 0.3 \text{ V}$; $V_{SS} = 0 \text{ V}$; refer to figures 33 and 34

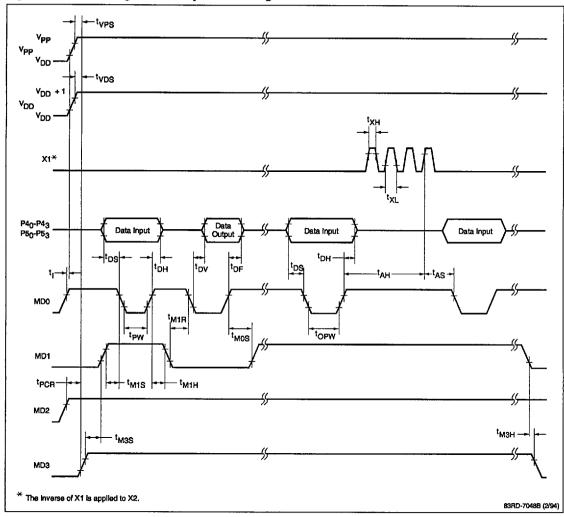
Parameter	Symbol	(Note 1)	Min	Тур	Max	Unit	Conditions
Address setup time to MD0 ↓ (Note 2)	tas	t _{AS}	2			μs	
MD1 setup to MD0 I	t _{M1S}	toes	2			μs	
Data setup to MD0 ↓	t _{DS}	t _{DS}	2			μs	
Address hold from MD0 † (Note 2)	^t AH	t _{AH}	2			μs	
Data hold from MD0 f	t _{DH}	t _{DH}	2		_	μs	
Data output float delay from MD0 f	t _{DF}	t _{DF}	0		130	ns	
V _{PP} setup to MD3 †	typs	typs	2			μs	
V _{DD} setup to MD3 †	tvos	tvcs	2			μs	
Initialized program pulse width	tpW	t _{PW}	0.95	1.0	1.05	ms	
Additional program pulse width	topw	topw	0.95		21	ms	
MD0 setup to MD1 f	t _{MOS}	t _{CES}	2			μs	
Data output delay from MD0 ↓	t _{DV}	t _{DV}			1	μs	$MD0 = MD1 = V_{IL}$
MD1 hold from MD0 †	t _{M1H}	toeh	2			με	t _{M1H} + t _{M1R} ≥ 50 <i>μ</i> s
MD1 recovery from MD0 ↓	t _{M1R}	tor	2			με	t _{M1H} + t _{M1R} ≥ 50 μs
Program counter reset	tPCR	_	10			μs	
X1 Input high and low-level width	txH, txL	_	0.125			μв	
X1 input frequency	fx	_			4.19	MHz	
Initial mode set	tı	_	2			με	
MD3 setup to MD1 †	t _{M3S}	_	2			με	
MD3 hold from MD1 ↓	t _{M3H}	_	2			μв	
MD3 setup to MD0 ↓	t _{M3SR}		2			μs	During Program Read cycle
Address to data output delay time (Note 2)	†DAD	tacc			2	με	_
Address to data output hold time (Note 2)	^t HAD	tон	0		130	ns	_
MD3 output hold from MD0 †	t _{M3HR}	_	2			με	_
Data output float delay from MD3 ↓	tDFR	_			2	με	=

These symbols correspond to those on the μPD27C256/C256A EPROM.

⁽²⁾ The internal address signal is incremented by one at the rising edge of the fourth X1 pulse; it is not connected to an external pin.

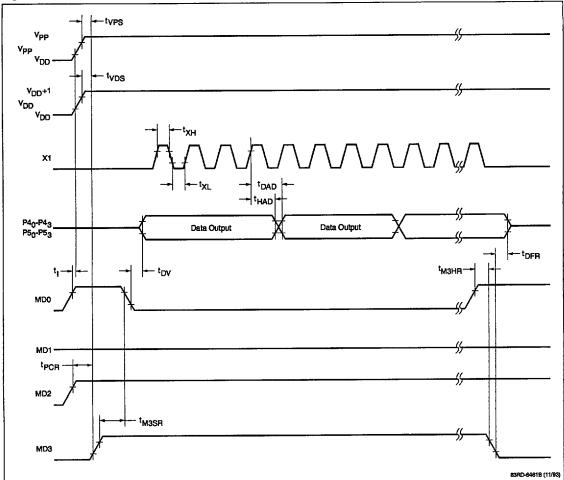


Figure 33. PROM Program Memory Write Timing











INSTRUCTION SET

There are four CPUs in the μ PD75x product line and one instruction set. The CPUs are (1) expanded high-end CPU, (2) high-end CPU, (3) standard CPU, and the (4) low-end CPU. The expanded high-end CPU uses the complete instruction set. The high-end CPU, standard CPU, and the low-end CPU use a subset of the instruction set. Table 1 shows the type of CPU in each μ PD75x device.

Table 1. Type of CPU in Each µPD75x Device

Expanded High-end	μPD75117H, 75P117H; μPD75217, 75218,75P218; μPD75237, 75238, 75P238; μPD75517, 75518, 75P518
High-end	μPD75104, 75104A, 75106, 75108, 75108F, 75108A, 75P108, 75P108B, 75112, 75112F; μPD75116, 75116F, 75P116, 75116H; μPD75206, 75208, 75C9208, 75212A, 75216A, 75P216A, 75C9216A, 75236; μPD75336, 75P336; μPD75512, 75516, 75P516
Standard	μPD75004, 75006, 75008, 75P008, 75028, 75036, 75P036, 75048, 75P048, 75P044, 75066, 75068, 75P068; μPD75268; μPD75268; μPD75304, 75304B, 75306, 75306B, 75308, 759308, 75P308, 75P316, 75P316, 75P3164, 75P3168, 75P3168, 75P328, 75P328, 75P328
Low-end	μPD75P402, 75402A

When the user assembles their program, they should designate the mask ROM device type rather than the OTP device at assembly time. This will prevent the user from using more ROM or RAM than is available on the mask ROM device. For example, the μ PD75P108 or μ PD75P116 can be used as an OTP for the μ PD75104 device, but both OTP versions have more ROM and RAM than the μ PD75104.

The user designates the device being used to the assembler using the -C command (-CXXX). This is not an optional command, and it must be input to the assembler. For example if the μ PD75104 is being used, the user invokes the assembler by typing:

RA75X FILENAME -C104

The -C104 on the command line tells the assembler that the μ PD75104 is being used. Once the assembler knows the chip, it will check to be sure the user does not exceed the amount of ROM or RAM, or use features not available on the chip

The µPD75x product line instruction set is unusually powerful for a 4-bit microcontroller. It contains instructions that operate on 1-bit, 4-bit, and 8-bit data. It contains 8-bit instructions which are generically equivalent to virtually every 4-bit instruction type. Specifically, the instruction set contains the following 8-bit instruction types:

- Arithmetic: ADD W/CARRY, ADD W/SKIP, SUB W/BORROW, SUB W/SKIP
- Logical: AND, OR, XOR
- Comparison: SKE (skip if equal)
- Transfer: MOV, MOVT, XCH, IN, OUT, PUSH, POP, BR, CALL
- Manipulation: INC W/SKIP, DEC W/SKIP

In addition, some of the 4-bit ports may be paired together to function as one 8-bit port. The combination of 8-bit ports and 8-bit instructions allows IN and OUT instructions to move a byte of data with one instruction.

The μ PD75x product line provides unusual instructions including the following types.

- · GETI instructions to reduce program size
- · Skip instructions
- String instructions
- Table reference instructions
- 1-byte relative branch instructions

GETI Instructions

GETI instructions are used to compact code, thereby reducing the ROM size and hence product cost. In general, GETI instructions reduce code by 10%. If the program is 9K bytes long, using GETI instructions will result in an 8K-byte ROM-based product.

The GETI converts 2-byte instructions and pairs of 1-byte instructions into a single 1-byte instruction. After the code is written, the code is analyzed fo find the most frequently used 2-byte instructions and/or the most frequently used pairs of 1-byte instructions. A GETI table (2 bytes per entry with up to 48 entries) based upon the most frequently used instructions is made. The frequently used instructions in the code are replaced by their respective GETI instructions. When a GETI instruction is encountered, the CPU gets and executes the instruction from the GETI table.



Because of the way it works, GETI is an acronym for "Get Instruction." An example is shown below:

	CSEG	IENT	;This is the GETI table.
MOVA:	MOV	A,@HL	;1-byte instruction.
	INCS	L	;1-byte instruction.
INCR:	INCS	@HL	;2-byte instruction.
	CSEG		;This is a code segment.
Start	DI		;This is a GETI instruction;
	MOV	HL,#0F4H	;it is 1-byte long.
	GETI	MOVA	Execution of this 1-byte
	MOV	A,#0FH	;instruction will cause the two ;1-byte instructions at MOVA in ;the GETI table to be executed.
	El		;Program continues after GETI ;at the MOV A,#0FH instruction

The GETI instruction can also convert 3-byte branch and CALL instructions into a single 1-byte instruction. In this case, the GETI table contains the branch or subroutine address.

Skip Instructions

Skip instructions replace the need for a conditional branch. Usable with 1, 4, or 8 bits of data, they are available in arithmetic, comparison, transfer, and manipulation type instructions. All skip instructions are implemented such that if the skip condition is met, the next instruction is skipped. For example:

LOOP:	SKT	PORT3.1
	BR	!LOOP
	14017	A V

In this example, the instruction SKT PORT3.1 tests port 3 bit 1 for a one; this is the skip condition. If port 3 bit 1 is zero, the skip condition is not met and the CPU executes the next instruction, which branches to LOOP and retests port 3 bit 1. When port 3 bit 1 is a one, the skip condition is met; the next instruction (BR !LOOP) is skipped and the MOV A, X instruction is executed.

String Instructions

The µPD75x product line has two types of string effect Instructions:

- (1) MOV A, #n4 or MOV XA, #n8
- (2) MOV HL,#n8

String effect means to place the same type of instruction in consecutive addresses. Only the first instruction of a string is executed normally; the remainder of the same type instructions in the string are treated as NOPs. The string instructions increase efficiency when setting constants into an accumulator (register A or XA) or into a data pointer (register pair HL). For example:

A0:	MOV	A,#0H
A1:	MOV	A,#1H
XA7:	MOV	XA,#0F8H
	SFT1	MRE

If the first instruction address in the string to be executed is A0, the two subsequent instructions (at A1 and at XA7) are treated as NOP instructions during program execution. The SET1 MBE instruction is the first instruction after A0 to be executed normally. If the first instruction address in the string to be executed is A1, the instruction at XA7 is treated as an NOP and the SET1 MBE instruction is the first after A1 to be executed normally.

Instruction Execution Times

The minimum instruction execution time is $0.95 \, \mu s$ with a 4.19-MHz clock. The PCC register can be used to program the CPU's instruction cycle time to 0.95, 1.91, or $15.3 \, \mu s$; all three speeds presuppose a 4.19-MHz crystal. Reducing the CPU clock speed will reduce the microcontroller's power consumption.

The machine cycle column in the Instruction Set table lists the number of cycles required to execute the instruction. One machine cycle equals one CPU clock period ϕ . In the machine cycle column, S equals the number of extra machine cycles required for skip operation when executing a skip instruction:

S	Skip Operation
0	No skip
1	1- or 2-byte instruction or GETI instruction is skipped.
2	3-byte instruction is skipped (BR !addr, CALL !addr)

Symbols, Operand Formats, and Addressing Areas

Table 2 defines the instruction set registers, flags, and symbols. Table 3 defines the instruction set operands and table 4 describes the addressing areas.



Table 2. Instruction Set Register, Flags, and Symbols

Symbol	Definition
A	A register; 4-bit accumulator
В	-
	B register; 4-bit register
C	C register; 4-bit register
<u>D</u>	D register; 4-bit register
<u>E</u>	E register; 4-bit register
H	H register; 4-bit register
<u>L</u>	L register; 4-bit register
<u>X</u>	X register; 4-bit register
XA	XA register pair; 8-bit accumulator
BC	BC register pair; 8-bit register
DE	DE register pair; 8-bit register
DL	DL register pair; 8-bit register
HL	HL register pair; 8-bit register
XA'	XA' register pair; 8-bit register
BC'	BC' register pair; 8-bit register
DE'	DE' register pair; 8-bit register
HL'	HL' register pair; 8-bit register
PC	Program counter
SP	Stack pointer
CY	Carry flag; bit accumulator
PSW	Program status word
MBE	Memory bank enable flag
RBE	Register bank enable flag
PORTn	Port n (n = 0-15)
IME	Interrupt master enable flag
IPS	Interrupt priority selection register
1Exxx	Interrupt enable flag
RBS	Register bank selection register
MBS	Memory bank selection register
PCC	Processor Clock Control Register
	Separation between address and bit
(xx)	The contents addressed by xx
xxH	Hexadecimal data
^	Logical AND
<u> </u>	Logical OR
₩	Logical Exclusive OR

Operation Representation Format and Description Method

An operand is entered in the operand field of each instruction according to the format of the instruction (see assembler specifications). When two or more entries are indicated in the description method, one should be selected. Capital letters and symbols must be entered exactly as shown. For immediate data, a proper numeric value or label should be entered as shown in table 3. See table 4 for a description of the addressing areas.

Table 3. Operand Formats

Symbol	Description
reg	X, A, B, C, D, E, H, L (reg = X, A, H, L for low-end CPU)
reg1	X, B , C , D , E , H , L (reg = X , H , L for low-end CPU)
rp rp1 rp2 rp' rp'1	XA, BC, DE, HL BC, DE, HL BC, DE XA, BC, DE, HL, XA', BC' DE', HL' BC, DE, HL, XA', BC' DE', HL'
rpa rpa1	HL, HL+, HL-, DE, DL DE, DL
n4 n8	4-bit immediate data or label 8-bit immediate data or label
mem (Note 1) bit	8-bit immediate data or label 2-bit immediate data or label
fmem pmem	FB0H-FBFH, FF0H-FFFH immediate data or label FC0H-FFFH immediate data or label
addr	Immediate data or label of the entire ROM area
faddr	11-bit immediate data or label
taddr	20H-7EH immediate data (where bit 0 = 0) or label
PORTn IExxx RBn MBn	Register bank n Memory bank n

Note:

(1) Memory address must be an even number in 8-bit processing.

μPD75316 Family



Table 4. Addressing Areas

Address Area (Note 1)	Addressing Area Description (Note 2)	Memory Area
1	MB = (MBE)•(MBS) (Note 3)	Data memory
2	MB = 0 (Note 4)	
3	MB = 0 : MB = 0 (00H-7FH) MB = 15 (80H-FFH) MBE = 1 : MB = MBS (Note 3)	
4	MB = 15, fmem = FB0H-FBFH (Note 5) FF0H-FFFH	
5	MB = 15, pmem = FC0H-FFFH (Note 5)	
6	addr immediate data or label of the entire ROM area up to 3F7FH	Program memory
7	addr = (current PC) - 15 to (current PC) - 1 or (current PC) + 2 to (current PC) + 16	
8	caddr x000H to xFFFH; x = 0H to FH and specifies a 4K area of ROM	
9	faddr = 0000H-07FFH	
10	taddr = 0020H-007FH	
11	addr1 = immediate data or label of the entire ROM area 0000H - 7F7FH	

- (1) Symbols 1 thru 11 refer to the Addressing Area column of the Instruction Set table.
- (2) MB = data memory bank that can be addressed.
- (3) MBS = 0 7, or 15.
- (4) MB = 0 regardless of the status of MBE and MBS.
- (5) MB = 15 regardless of the status of MBE and MBS.

NEC

Instruction Set

Mnemonic	Operand	Operation	Bytes	MC†	AA†	Skip Condition	EHE† CPU	HE† CPU	Std† CPU	
Transfer										
MOV	A, #n4	A ← n4	1	1		String A	х	х	х	×
	reg1, #n4	reg1 ← n4	2	2			х	x	х	_
	XA, #n8	XA ← n8	2	2		String A	x	x	×	×
	HL, #n8	HL ← n8	2	2		String B	x	x	x	×
	rp2, #n8	rp2 ← n8	2	2			x	x	х	_
	A, @HL	A ← (HL)	1	1	1		x	x	x	x
	A, @HL+	A ← (HL), then L←L+1	1	2+S	1	L = 0	x	х	_	_
	A, @HL-	A ← (HL), then L←L-1	1	2+8	1	L = FH	x	×	_	_
	A, @rpa1	A ← (rpa1)	1	1	2		×	х	x	_
	XA, @HL	XA ← (HL)	2	2	1		x	×	х	
	@HL, A	(HL) ← A	1	1	1		×	×	х	×
	@HL, XA	(HL) ← XA	2	2	1		x	x	х	
	A, mem	A ← (mem)	2	2	3		x	x	x	×
	XA, mem	XA ← (mem)	2	2	3		×	x	×	×
	mem, A	(mem) ← A	2	2	3		х	х	х	х
	mem, XA	(mem) ← XA	2	2	3		x	×	x	x
	A, reg	A ← (reg)	2	2			х	×	х	_
	XA, rp'	XA ← rp¹	2	2			х	x	х	_
	reg1, A	reg1 ← A	2	2			x	x	×	_
	rp'1, XA	rp'1 ← XA	2	2			x	X	х	
XCH	A, @HL	A ↔ (HL)	1	1	1		х	x	х	×
	A, @HL+	A ↔ (HL), then L←L+1	1	2+8	1	L = 0	x	х	_	
	A, @HL-	A ↔ (HL), then L←L-1	1	2+8	1	L = FH	x	x		
	A, @rpa1	A ↔ (rpa1)	1	1	2		x	x	x	
	XA, @HL	XA ↔ (HL)	2	2	1		х	×	х	_
	A, mem	A ↔ (mem)	2	2	3		×	×	х	×
	XA, mem	XA ↔ (mem)	2	2	3		x	х	х	×
	A, reg1	A ↔ (reg1)	1	1			×	х	х	х
	XA, rp'	XA ↔ rp'	2	2			×	×	x	
MOVT	XA, @PCDE	XA ← (PC ₁₄₋₈ + DE) _{ROM}	1	3			х	х	х	_
	XA, @PCXA	XA ← (PC ₁₄₋₈ + XA) _{ROM}	1	3			х	х	х	x
	XA, @BCDE	$XA \leftarrow (B_{2-0} + CDE)_{ROM}$	1	3	6		×	_	_	
	XA, @BCXA	$XA \leftarrow (B_{2-0} + CXA)_{ROM}$	1	3	6	Note 1	х			

† MC: Machine Cycle AA: Addressing Area EHE: Expanded High-End HE: High End Std: Standard LE: Low End x = Instruction available— = Instruction not available



Mnemonic	Operand	Operation	Bytes	MCt	AA†	Skip Condition	EHE† CPU	HE† CPU	Std† CPU	LE†
Transfer (cont)									
MOV1	CY, fmem.bit	CY ← (fmem.bit)	2	2	4		х	×	_	
	CY, pmem.@L	$\begin{aligned} \text{CY} &\leftarrow (\text{pmem}_{7\text{-}2} + \text{L}_{3\text{-}2} \\ . \text{bit}(\text{L}_{1-0})) \end{aligned}$	2	2	5		x	X		_
	CY, @H+ mem.bit	CY ← (H+ mem ₃₋₀ .bit)	2	2	1		х	x		_
	fmem.bit, CY	(fmem.bit) ← CY	2	2	4		x	x		
	pmem.@L, CY	$(pmem_{7-2} + L_{3-2}.bit (L_{1-0})) \leftarrow CY$	2	2	5		х	х		_
	CY, @H+ mem.bit	(H+ mem ₃₋₀ .bit) ← CY	2	2	1		×	х	_	_
Arithmetic	;									
ADDS	A, #n4	A ← A+ n4	1	1+S		Саггу	х	х	x	x
	XA, #n8	XA ← XA+ n8	2	2+8		Carry	x	х	_	
	A, @HL	A ← A+ (HL)	1	1+S	1	Carry	х	х	x	×
	XA, rp'	XA ← XA+ rp′	2	2+8		Carry	х	x	_	
	rp'1, XA	rp'1 ← rp'1+XA	2	2+8		Carry	х	х	_	
ADDC	A, @HL	A, CY ← A+ (HL)+CY	1	1	1		x	x	х	×
	XA, rp'	XA, CY ← XA+ rp'+ CY	2	2			х	х	_	
	rp'1, XA	rp'1, CY ← rp'1+XA+CY	2	2			x	x	_	
SUBS	A, @HL	A ← A-(HL)	1	1+S	1	Borrow	х	х	x	
	XA, rp'	XA ← XA-rp′	2	2+S		Borrow	х	х		_
	rp'1, XA	rp′1 ← rp′1–XA	2	2+ S		Borrow	х	х		
SUBC	A, @HL	A, CY ← A – (HL) – CY	1	1	1		х	х	x	
	XA, rp'	XA, CY ← XA-rp'-CY	2	2			x	х	_	
	rp'1, XA	rp'1, CY ← rp'1-XA-CY	2	2			х	x	_	
AND	A, #n4	A←A ^ n4	2	2			x	х	x	
	A, @HL	A←A ^ (HL)	1	1	1		x	х	x	х
	XA, rp'	XA ← XA ∧ rp′	2	2			х	х	_	
	rp'1, XA	rp′1 ← rp′1 ^ XA	2	2			x	х		
OR	A, #n4	A ← A ∨ n4	2	2			x	x	x	
	A, @HL	A ←A ∨ (HL)	1	1	1		x	х	х	х
	XA, rp'	XA ← XA V rp′	2	2			x	х	_	
	rp'1, XA	rp′1 ← rp′1 ∨ XA	2	2			×	x		
XOR	A, #n4	A ← A ∀ n4	2	2			×	x	×	
	A, @HL	A ← A ∀ (HL)	1	1	1		x	x	X	х
	XA, rp'	XA ← XA ∀ rp′	2	2			x	×	_	
	rp'1, XA	rp'1 ← rp'1 ∀ XA	2	2			×	х	_	

† MC: Machine Cycle AA: Addressing Area EHE: Expanded High-End HE: High End Std: Standard LE: Low End x = Instruction available--- = Instruction not available



Mnemonic	Operand	Operation	Bytes	MC†	AA†	Skip Condition	EHE†	HE† CPU	Std† CPU	LE†
Accumula	tor Manipula	ition								
RORC	A	$CY \leftarrow A_0, A_3 \leftarrow CY, A_{n-1} \leftarrow A_n$	1	1			х	х	×	×
NOT	A	$A \leftarrow \overline{A}$	2	2			×	х	×	х
Increment	/Decrement									
INCS	reg	reg ← reg+1	1	1+S		reg = 0	×	x	×	x
	rp1	rp1 ← rp1+1	1	1+8		rp1 = 00H	x	х	_	_
	@HL	(HL) ← (HL)+1	2	2+S	1	(HL) = 0	х	×	x	_
	mem	(mem) ← (mem)+1	2	2+8	3	(mem) = 0	×	x	×	×
DECS	reg	reg ← reg-1	1	1+S		reg = FH	x	x	х	х
	rp'	rp' ← rp'-1	2	2+ S		rp' = FFH	х	x		
Comparis	on									
SKE	reg, #n4	skip if reg = n4	2	2+8		reg = n4	×	×	×	×
	@HL, #n4	skip if (HL) = n4	2	2+8	1	(HL) = n4	×	×	x	_
	A, @HL	skip if A = (HL)	1	1+8	1	A = (HL)	×	х	×	×
	XA, @HL	skip if XA = (HL)	2	2+S	1	XA = (HL)	×	×		
	A, reg	skip if A = reg	2	2+8		A = reg	×	x	x	
	XA, rp'	skip if XA = rp'	2	2+ S		XA = rp'	×	x	_	
Carry Flag	Manipulati	on								
SET1	CY	CY ← 1	1	1			×	×	×	×
CLR1	CY	CY ← 0	1	1			×	x	×	×
SKT	CY	skip if CY = 1	1	1+5	•	CY = 1	x	x	x	х
NOT1	CY	CY ← CY	1	1			×	x	х	x
Memory B	it Manipulati	ion								
SET1	mem.bit	(mem.bit) ← 1	2	2	3		×	×	x	х
	fmem.bit	(fmem.bit) ← 1	2	2	4		×	x	х	×
	pmem.@L	(pmem ₇₋₂ + L ₃₋₂ .bit (L ₁₋₀)) ← 1	2	2	5		×	x	х	
	@H+ mem.bit	(H + mem ₃₋₀ ,bit) ← 1	2	2	1		x	x	x	_
CLR1	mem.bit	(mem.bit) ← 0	2	2	3		×	х	х	х
	fmem.bit	(fmem.bit) ← 0	2	2	4		×	х	х	х
	pmem.@L	(pmem ₇₋₂ + L ₃₋₂ .bit (L ₁₋₀)) ← 0	2	2	5		x	x	х	_
	@H+ mem.bit	(H + mem ₃₋₀ .bit) ← 0	2	2	1		x	x	х	_
† MC: Mach AA: Addres EHE: Expa		HE: High End Std: Standard LE: Low End	x = Instru — = Instru							

μPD75316 Family



Mnemonic	Operand	Operation	Bytes	MC†	AA†	Skip Condition	EHE†		Std† CPU	LE† CPU
Memory B	it Manipulati	on (cont)								
SKT	mem.bit	skip if (mem.bit) = 1	2	2+8	1	(mem.bit) = 1	x	х	х	х
	fmem.bit	skip if (fmem.bit) = 1	2	2+S	4	(fmem.bit) = 1	х	х	x	×
	pmem.@L	skip if (pmem ₇₋₂ + L_{3-2} .bit(L_{1-0})) = 1	2	2+\$	5	(pmem.@L = 1)	x	x	х	_
	@H+ mem.bit	skip if (H+ mem ₃₋₀ .bit) = 1	2	2+\$	1	(@H+ mem.bit) = 1	х	х	х	_
SKF	mem.bit	skip if (mem.bit) = 0	2	2+\$	3	(mem.bit) = 0	х	х	x	х
	fmem.bit	skip if (fmem.bit) = 0	2	2+8	4	(fmem.bit) = 0	х	x	x	x
	pmem.@L	skip if (pmem ₇₋₂ + L_{3-2} .bit(L_{1-0})) = 0	2	2+S	5	(pmem.@L = 0)	×	х	x	
	@H+ mem.bit	skip if $(H + mem_{3-0}.bit) = 0$	2	2+ S	1	(@H+ mem.bit) = 0	x	х	x	
SKTCLR	fmem.bit	skip if (fmem.bit) = 1 and clear	2	2+8	4	(fmem.bit) = 1	×	×	x	х
	pmem.@L	skip if (pmem ₇₋₂ + L_{3-2} .bit(L_{1-0})) = 1 and clear	2	2+\$	5	(pmem.@L = 1)	x	x	X	_
	@H+ mem.bit	skip if (H+ mem ₃₋₀ .bit) = 1 and clear	2	2+S	1	(@H+ mem.bit) = 1	x	x	х	_
AND1	CY, fmem.bit	CY ← CY ∧ (fmem.bit)	2	2	4		×	x	х	х
	CY, pmem.@L	$CY \leftarrow CY \land (pmem_{7-2} + L_{3-2}.bit(L_{1-0}))$	2	2	5		×	x	x	
	CY, @H+ mem.bit	$CY \leftarrow CY \land (H + mem_{3-0}.bit)$	2	2	1		x	x	x	_
OR1	CY, fmem.bit	CY ← CY ∨ (fmem.bit)	2	2	4		x	x	x	x
	CY, pmem.@L	$CY \leftarrow CY \lor (pmem_{7-2} + L_{3-2}.bit(L_{1-0}))$	2	2	5		x	x	×	
	CY, @H+ mem.bit	CY ← CY ∨ (H+ mem ₃₋₀ .bit)	2	2	1		x	×	x	
XOR1	CY, fmem.bit	CY ← CY ∀ (fmem.bit)	2	2	4		х	x	x	х
	CY, pmem.@L	$CY \leftarrow CY \forall (pmem_{7-2} + L_{3-2})$ 2.bit (L ₁₋₀))	2	2	5		x	x	х	_
	CY, @H+ mem.bit	CY ← CY ∀ (H+ mem ₃₋₀ .bit)	2	2	1		х	x	х	_
Branch			-							
BR	addr	PC ₁₃₋₀ ← addr ₁₃₋₀		-	6		×	×	×	×
(Note 2)	laddr (Note 2)	PC ₁₄ ← 0, PC ₁₃₋₀ ← addr	3	3	6		х	x	x	_
	\$addr (Note 2)	PC ← addr	1	2	7		х	х	×	×
† MC: Mach	nine Cycle essing Area	HE: High End Std: Standard		ction availa						

EHE: Expanded High-End

LE: Low End



Instruction Set (cont)

Mnemonic	Operand	Operation	Bytes	MC†	AA†	Skip Condition	EHE†	HE† CPU	Std† CPU	LE†
Branch (co	ont)									
вясв	lcaddr (Note 2)	PC ₁₄₋₁₂ ← PC ₁₄₋₁₂ , PC ₁₁₋₀ ← caddr ₁₁₋₀	2	2	8		х	x	x	x
BR	PCDE	PC ₁₄₋₈ ← PC ₁₄₋₈ , PC ₇₋₀ ← DE	2	3	11		х	х	_	_
	PCXA	PC ₁₄₋₈ ← PC ₁₄₋₈ , PC ₇₋₀ ← XA	2	3	11		х	×		_
	BCDE (Note 3)	PC ₁₄₋₁₂ ← B ₂₋₀ , PC ₁₁₋₀ ← CDE	2	3	11		x	_	_	
	BCXA (Note 3)	PC ₁₄₋₁₂ ← B ₂₋₀ , PC ₁₁₋₀ ← CXA	2	3	11		x		_	_
BRA (Note 2)	!addr1	PC ← addr1	3	3	11		х		_	
Subroutin	e Stack Cont	trol								
CALL (Note 4)	!addr	$(SP-4)(SP-1)(SP-2) \leftarrow PC_{11-0}$ $(SP-3) \leftarrow (MBE, RBE, PC_{13,12})$ $PC_{13-0} \leftarrow addr, SP \leftarrow (SP-4)$	3	3	6		х	x	x	_
CALLA (Notes 4, 5)	!addr	(SP-1) ← *, *, *, *, *, (SP-2) ← *, *, MBE, RBE, (SP-3) (SP-4) (SP-5) (SP-6) ← PC ₁₄₋₀ , SP ← SP-6	3	3	11		х		_	_
CALLF	lfaddr	$(SP-4)(SP-1)(SP-2) \leftarrow PC_{11-0}$ $(SP-3) \leftarrow (MBE, RBE, PC_{13,12})$ $PC_{13-0} \leftarrow 000, faddr,$ $SP \leftarrow (SP-4)$	2	2	9		х	х	x	x
CALLF (Notes 5, 6)	!faddr	(SP-1) ← *, *, *, *, * (SP-2) ← *, *, MBE, HBE, (SP-3) (SP-4) (SP-5) (SP-6) ← PC ₁₄₋₀ , PC ₁₄₋₀ ← 0000, faddr, SP ← SP-6	2	3	9		х	_	_	
RET		(MBE, RBE, PC _{13,12}) \leftarrow (SP+1) PC ₁₁₋₀ \leftarrow (SP), (SP+3)(SP+2) SP \leftarrow (SP+4)	1	3			_	х	x	x
RET (Notes 5, 6)		PC ₁₁₋₀ ← (SP) (SP+2)(SP+3) *, PC ₁₄₋₁₂ ← (SP+1), *, *, MBE, RBE ← (SP+4) SP ← SP+6	1	3			x	_	_	
RETS		(MBE, RBE, PC _{13,12}) ← (SP+1) PC ₁₁₋₀ ← (SP) (SP+3) (SP+2) SP ← (SP+4), then skip unconditionally	1	3+S		Unconditional	_	х	x	x
RETS (Notes 5, 6)		$PC_{11-0} \leftarrow (SP) (SP+3) (SP+2)$ *, $PC_{14-12} \leftarrow (SP+1)$ *, *, MBE, RBE $\leftarrow (SP+4)$ $SP \leftarrow SP+6$, then skip unconditionally	1	3+S		No condition	x	_		
† MC: Machine Cycle HE: High End AA: Addressing Area Std: Standard EHE: Expanded High-End LE: Low End		Std: Standard		ction availab uction not a						_

μPD75316 Family



Mnemonic	Operand	Operation	Bytes	MC†	AAt	Skip Condition	EHE† CPU		Std† CPU	
Subroutin	e Stack Cont	trol (cont)								
RETI		MBE, RBE, PC_{13} $PC_{12} \leftarrow$ (SP+1) $PC_{11-0} \leftarrow$ (SP), (SP+3) (SP+2) $PSW \leftarrow$ (SP+4) (SP+5), SP \leftarrow (SP+6)	1	3				x	x	x
RETI (Notes 5, 6)		$PC_{11-0} \leftarrow (SP), (SP+3)(SP+2)$ *, $PC_{14-12} \leftarrow (SP+1)$ $PSW \leftarrow (SP+4)(SP+5)$ $SP \leftarrow SP+6$	1	3			x		_	_
PUSH	гр	(SP-1)(SP-2) ← rp, SP ← (SP-2)	1	1			×	X	X	х
	BS	(SP-1) ← MBS, (SP-2) ← RBS, SP ← (SP-2)	2	2			x	×	×	
POP	гр	rp ← (SP+1)(SP), SP ← (SP+2)	1	1			x	x	х	×
	BS	$MBS \leftarrow (SP+1), RBS \leftarrow (SP),$ $SP \leftarrow (SP+2)$	2	2			x	х	x	
Interrupt	Control									
El		IME ← 1	2	2			x	x	х	х
	IExxx	IExxx ← 1	2	2			х	×	x	х
DI		IME ← 0	2	2			x	x	х	x
	IExxx	IExxx ← 0	2	2			x	x	×	×
Input/Out	put (Note 7)									
IN	A, PORT _n	A ← PORT _n	2	2			х	x	x	x
	XA, PORT _n	XA ← PORT _{n+1} , PORT _n	2	2			х	×	x	
OUT	PORT _n , A	PORT _n ← A	2	2			х	x	x	х
	PORT _n , XA	PORT _{n+1} , PORT _n ← XA	2	2			x	х	x	
CPU Cont	rol									
HALT		Set HALT mode (PCC.2 ← 1)	2	2			х	x	х	x
STOP	**	Set STOP mode (PCC.3 ← 1)	2	2			×	x	x	×
NOP		No operation	1	1			×	×	x	x
Special										
SEL	RBn	RBS ← n; (n = 0-3)	2	2			x	×		
	MBn	MBS ← n	2	2			×	x	x	

x = Instruction available

- = Instruction not available

† MC: Machine Cycle

AA: Addressing Area EHE: Expanded High-End HE: High End

Std: Standard LE: Low End

⁶⁶



Instruction Set (cont)

Mnemonic	Operand	Operation	Bytes	MC†	AA†	Skip Condition	EHE†	HE† CPU		LE† CPU
GETI (Notes 8, 9)	taddr	For BR instructions: (TBR in GETI table) PC ₁₃₋₀ ← (taddr) _{5-0,} (taddr+1)	1	3	10	Depends on the referenced instruction	_	х	х	
		For CALL instructions: (TCALL in GETI table) (SP-4), (SP-1), (SP-2) ← PC ₁₁₋₀ ; (SP-3) ← MBE, RBE, PC ₁₃₋₁₂ ; PC ₁₃₋₀ ← (taddr) ₅₋₀ , (taddr+1), SP ← SP-4	1	3	10	Depends on the referenced instruction		x	x	
		For instructions other than TBR or TCALL, the instruction at (taddr) and (taddr+1) is executed.	1	3	10	Depends on the referenced instruction	_	x	x	

- (1) Available on all expanded high-end CPUs except µPD75217.
- (2) Optimum instruction is selected by the assembler from BRA laddr, BR laddr, BRCB lcaddr, and BR \$addr.
- (3) Can be used for expanded high-end CPU except μPD75217
- (4) For parts that contain the expanded high-end CPU and use the 32K mode, the CALL instruction operates the same as the CALLA instruction except the CALL takes 4 machine cycles and the CALLA takes 3 machine cycles.
- (5) * = undefined value.
- (6) This operation is only for parts with expanded high-end CPU operating in the 32K mode, or for parts with the expanded high-end CPU and no 32K mode.
- (7) When executing the IN/OUT instruction, either MBE must be reset to 0, or MBE and MBS must be set to 1 and 15, respectively.
- (8) TBR and TCALL are GETI table pseudoinstructions.
- (9) The GETI instruction shown applies to the high-end and standard CPUs. The GETI instruction is not available in the low-end CPU. For parts with the expanded high-end CPU, see the User's Manual.



SOLDERING

Packaging and Soldering Information

Part Number	Package	Package Drawing	Recommended Soldering Code			
μΡD75304GF-xxx-3B9 μΡD75306GF-xxx-3B9 μΡD75308GF-xxx-3B9 μΡD75312GF-xxx-3B9 μΡD75316GF-xxx-3B9	80-pin plastic QFP (14 x 20 mm)	P80GF-80-3B9-1	IR30-00-1, VP15-00-1, WS60-00-1			
μPD75P308GF	80-pin plastic QFP (14 x 20 mm)	P80GF-80-3B9-1	IR30-162-1, VP15-162-1, WS60-162-1			
μPD75P316AGF	80-pin plastic QFP (14 x 20 mm)	P80GF-80-3B9-1	IR30-207-1, VP15-207-1, WS60-207-1			
μΡD75P308K μPD75P316AK	80-pin ceramic LCC w/window	X80KW-80A	Soldering not recommended			

Soldering Conditions

Method (Note 1)	Code (Note 2)	Soldering Conditions	Exposure Limit (Note 3)		
Infrared reflow	IR30-00-1	Package peak temp: 230°C	No limit		
	IR30-162-1	Time: 30 sec max (210°C min)	Max no. of days: 2 (thereafter, 16 hours baking at 125°C is required)		
	IR30-207-1	-	Max no. of days: 7 (thereafter, 20 hours baking at 125°C is required)		
Vapor phase	VP15-00-1	Package peak temp: 215°C	No limit		
	VP15-162-1	Time: 40 sec max (200°C min)	Max no. of days: 2 (thereafter, 16 hours baking at 125°C is required)		
	VP15-207-1		Max no. of days: 7 (thereafter, 20 hours baking at 125°C is required)		
Wave soldering	WS60-00-1	Solder bath temp: 260°C max	No limit		
	WS60-162-1	Time: 10 sec max	Max no. of days: 2 (thereafter, 16 hours baking at 125°C is required)		
	WS60-207-1	-	Max no. of days: 7 (thereafter, 20 hours baking at 125°C is required)		
Pin partial heating		Pin partial temp: 300°C max Time: 3 sec max (per device side)			

- (1) Do not use different soldering methods together. However, on all devices the pin partial heating soldering method can be used alone or in combination with other soldering methods.
- (2) The maximum number of soldering operations is one or two as indicated by the last digit of the soldering code: -1 or -2.
- (3) Maximum no. of days refers to the number of days after unpacking the dry pack. Storage conditions are 25°C and 65% RH max.



PACKAGE DRAWINGS

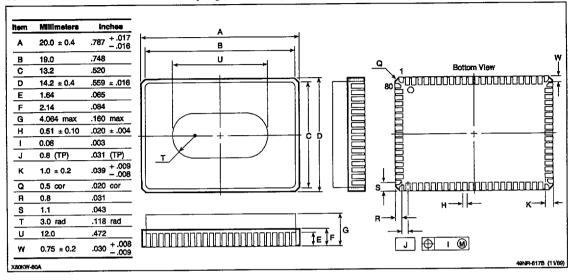
80-Pin Plastic QFP, 14 x 20 mm (Dwg P80GF-80-3B9-1)

ltem	Millimeters	Inches	A
Α	23.6 ±0.4	.929 ±.016	В
В	20.0 ±0.2	.787 +.009 008	
С	14.0 ±0.2	.551 +.009 008	
D	17.6 ±0.4	.693 ±.016	64 41 41
F	1.0	.039	
G	0.8	.031	
н	0.35 ±0.10	.014 +.004 005	
1	0.15	.008	
J	0.8 (TP)	.031 (TP)	
κ	1.8 ±0.2	.071 +.009 008	
L	0.8 ±0.2	.031 +.009 008	
М	0.15 +0.10 -0.05	.006 +.004 002	24
N	0.15	.006	†
P	2.7	.106	F
Q	0.1 ±0.1	.004 ±.004	→ - - - - - - - - - -
R	0.1 ±0.1	.004 ±.004	G H TI
S	3.0 max	.118 max	
Р	Pin Detail) <u>+</u>	
	A	A R	



PACKAGE DRAWINGS (cont)

80-Pin Ceramic LCC With Window (Dwg x80KW-80A)





PACKAGE DRAWINGS (cont)

80-Pin Ceramic QFP For Engineering Samples

